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computer programs EMX and EMX2 for electron microprobe data processing

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COMPUTER PROGRAMS EMX AND EMX2 FOR ELECTRON  
MICROPROBE DATA PROCESSING

by

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## I. INTRODUCTION

Electron probe microanalysis provides a rapid method for the chemical analysis of volumes of the order of  $10^{-11}\text{cm}^3$  ( $10\mu\text{m}^3$ ), however, the process of converting the data, which come from the probe in the form of measured x-ray intensities, into absolute concentrations is long and cumbersome when carried out by conventional methods. Since the task is obviously one for a computer, Fortran-63 programs have been written that not only perform the necessary absorption and fluorescence corrections but also carry out almost the entire data handling operation. With these programs, the amount of data that would come from a normal eight hours of microprobe operation can be processed in a little more than one minute of CDC 3600 computer time, at a fraction of the cost that would be required for an individual to do the work using a desk calculator.

In writing these programs we have tried to satisfy three basic aims: A) versatility, B) use of the most appropriate correction procedures, and C) elimination of all hand calculating and data sorting.

### A. Versatility

The programs are suitable for any type of problem from the analysis of a binary alloy to that of a complex mineral system involving as many as twenty elements. They accept any reasonable amount of data in any sequence in which the probe operator wishes to gather them and furnish the results in graphical as well as printed form.

Part of the flexibility of this method comes from the fact that we have written not one but two programs, which may be run together or separately. The first program, EMX, takes raw data from the probe, corrects for deadtime, drift, and background, and calculates the ratio of observed intensities (sample over standard) times the concentration of the element in its standard; the results from EMX are referred to herein as the first approximation\*. The output from Program EMX can also be written on magnetic tape or punched on cards for use as input to Program EMX2.

The second program, EMX2, makes corrections for absorption and fluorescence by characteristic radiation. Additional corrections, such as that for atomic number effect, can be added later when a satisfactory correction procedure is determined.

\*Note that our first approximation is not the "premiere approximation" of Castaing (2) but refers only to the output of the first program (EMX). The first approximation is thus the concentration of the particular element in its standard times the ratio (sample to standard) of observed intensities corrected for deadtime, drift and background but not for absorption or fluorescence.

As many as 800 probe data points (each point being made up of from one to 100 separate readings)\* may be included in one problem, and any number of problems may be grouped in one computer run. Within each problem, the probe operator may analyze up to nine different elements in the first program. For the second program, output from two or more problems may be grouped together; this allows the analysis of samples containing as many as 20 elements.

Some savings in time and computer costs are made if the two programs are run together, but often this is not desirable. The analyst may wish to look at the first approximations before deciding if the results are worth correcting further. Or he may have analyzed only some of the elements present in the sample and wish to measure or estimate the concentrations of others before correcting for absorption and fluorescence. Another practical advantage of the two-program method is that it effectively increases the storage capacity of the computer and enables one to handle a large amount of data.

Program EMX2 can be modified slightly to run "in reverse." If two cards in the main program are changed\*\* true concentrations can be entered as input data; the output then shows what the observed intensity ratios will be if the correction procedures used are both valid and complete.

### B. Appropriate Correction Procedures

When one is writing a computer program and changing from manual to automatic data processing, it is an opportune time to re-examine all the techniques and formulas used in the correction of microprobe data for quantitative analysis. We would be failing to make use of all the advantages offered by electronic computers if we continued to approach problems from the point of view of a man with a slide rule. Several approximations that were previously tolerated because more rigorous calculations would have been too time consuming are no longer justified.

\*For purposes of this discussion, a "reading" is defined as one line of data as it comes from the probe and includes the counting time, sample current, counts on three spectrometers, a six-digit code, and, if desired, an identifying label (NAME). A "data point" is made up of one or more readings of the same sample. All the readings in a data point will be added together to find the average counts per second for that data point. A "data set" includes consecutive probe data points taken without a break. A background or standard peak data point may pertain to all the sample data points within the set, but it will not be used to correct data in another set. Therefore, each data set must contain the necessary standard and background readings.

\*\*Change Statement 11 to  $\text{OCON(I)} = \text{OCON(I)} / (\text{SCF(I)} * \text{SCON(I)})$ . Change fifth statement after Statement 400 to  $\text{CON2} = \text{OCON(I)} * (\text{FCHI} * (1.0 + \text{FL}))$ . Run with  $\text{IMAX} = 1$ .

Consider, for example, the "simple" formula for fluorescence corrections derived by Wittry (1):

$$I'_f = I_A \left[ \frac{U_B \ln U_B - U_B + 1}{U_A \ln U_A - U_A + 1} \right] \left[ \frac{X_i^B \omega_k^B (r_k^A - 1) \sin \theta}{2} \right] \left[ \frac{X^{-7.6} (1 - C_A) \ln(1 + u)}{C_A + (1 - C_A) X^3} \right] \quad (1)$$

This formula was ingeniously arranged to take the form of three separate factors, each dependent upon only one variable. This is a considerable advantage to a person making corrections by hand. A computer cannot readily read values from a graph, but it can evaluate complicated functions extremely quickly. We have worked out a formula for fluorescence corrections which combines Wittry's voltage dependence factor with the formula of Castaing (2), which takes into account the effects of depth of penetration in the sample. Theoretically the combination formula appears more satisfactory than the others, but whether it is a significant improvement remains to be seen.

For the absorption correction the computer program now uses Philibert's (3) formula with Duncumb and Shields' (4) effective sigma, but it is hoped that a correction method based on sounder theoretical considerations can be developed. One of the major advantages of computer handling of microprobe data is that it removes much of the drudgery from the process of accumulating large quantities of analytical data on known samples with a view to evaluating correction methods. The effects of making changes in the correction formulae can readily be seen by simple recycling of the data through the computer. Evaluations of the modified fluorescence correction used in EMX2 and of the absorption correction are being attempted by the analysis of simple known phases, particularly binary alloys. The ability to run the program "in reverse" and generate observed intensities from known compositions proves very valuable in this project.

#### C. Elimination of Manual Data Processing

Our final aim, which was actually the most difficult to carry out, was to eliminate all hand calculation as well as the need to transfer data to some special form. On the other hand, we did not wish to restrict the probe analyst to following any certain sequence of collecting data. For Program EMX, output from the probe can be on punched paper tape, punched cards, magnetic tape, or typewritten pages which can go directly to the key-punch operator. The data do not need to be rearranged in any way--assuming, of course, that the probe operator did not forget to include the necessary standard and background readings or make some other error. The program user need prepare only one data card for each element analyzed in the problem (the Element Card, see Appendix 2) plus one card giving general information about the entire problem (the Identification Card).

The technique by which this has been accomplished is really the key to the entire EMX program. It consists in the assignment of a six-

digit code number to each line-of-probe output at the time it comes from the probe. Two digits of the code refer to each of the three spectrometers, one indicating which element of the sample is being analyzed and the other specifying the type of reading--standard peak, sample peak, standard background, sample background, or dead-time data (see Sec. II-A). These code numbers could be written by hand on the data sheet that comes from the probe, but we have actually modified our microprobe by adding a "green box", which is located conveniently for the probe operator and connected to the printout device. By setting the six switches on this box, the operator presets the numbers in the code column before the data is printed or punched.

Because each line of data from the probe is identified by this code number, Program EMX can accept data in any order in which it is run, with no need for it to be arranged into a particular sequence. The operator can take readings on standard peaks first, last, and/or anywhere in the middle of the data. Background data points can appear before and/or after each peak data point, or one background data point (or pair of points) can be subtracted from all peaks for the same element. The user may take one or more readings on each point; in the latter case the computer averages the readings for each data point and computes the standard deviations. It is unnecessary to take the same number of readings on each type of data; one could, for example, take two readings on each sample peak, a large number of readings on the first standard peak (to check probe stability), and some other number of readings on later standard peaks. Data points on samples in any one problem, however, must contain the same number of readings.

Further routine paper work has been eliminated by permanent storage within Program EMX2 of all the various constants necessary for carrying out corrections involving any elements. Of course, this data is not really permanent; it can be changed easily when better values become known. The program does not store all the values of  $u/\rho$ ,  $\sigma$ ,  $K$ -fluorescence yield, critical excitation potential, and absorption jump ratio, but rather the constants necessary for calculating them. Heinrich's method of calculating mass absorption coefficients and absorption jump ratios is used, so his values for absorption edges plus the necessary coefficients and exponents are stored. Also included are the atomic weights and characteristic wavelengths of all the elements (see Sec. III-A).

We chose this method because our computer does not have enough quick access storage space to hold vast numerical tables, and it can re-evaluate functions more economically than it could look up the answers on a tape. For a typical problem involving six elements plus oxygen, the CDC-3600 computer took 10 milliseconds to decide which elements will fluoresce which other elements. Calculation of all the required physical constants, 62 separate variables in all, took 38 milliseconds. This procedure is obviously faster and more economical than looking up numbers in tables and removes the possibility of human error in so doing.

\* \* \*

The remainder of this report is devoted to a detailed description of the two computer programs and how to use them. Neither the history of microprobes nor the theory behind methods of correction for absorption and fluorescence effects will be discussed. For a recent, comprehensive treatment of the latter topic, the reader is referred to Philibert (3). An English translation of this paper is presently being prepared by our group and will be available soon.

Appendix 1 contains Fortran listings of the two programs, and data input specifications are in Appendix 2. Appendix 3 is made up of flow diagrams of most of the routines in the programs for those who wish to understand the logic of the programs and/or modify them.

Programs EMX and EMX2 are written in CDC Fortran-63 and should work in their present form on most CDC 3600 or 1604 computers. After conversion to IBM Fortran they would be suitable for use with other large computers such as IBM 7094.\*

\*Program EMX requires about 23,000 storage locations, of which 11,000 are for the program itself and 12,000 for the data required for 800 data points. Program EMX2 requires 12,650 locations--2,000 for the program, 5,000 for physical constant data, and about 12,000 for data involved in a problem of up to 500 samples with up to 20 elements each. The programs were written without any great effort to save space, and storage requirements could be greatly reduced by modified programming and reduction of the amount of data handled at once. However, modification of the programs for a really small computer would be extremely difficult.

Such conversion is relatively simple and can be done by any experienced programmer.\*\*

The programs were designed for use with an Applied Research Laboratories electron probe microanalyser. Because the data input routines handle data only in the format in which it comes from our microprobe, further modifications will be required by some users. The graph plotting routines, which were developed by California Computer Products, Inc., for use with their Calcomp 165 incremental plotter, will also have to be replaced with different routines if the program is to be used with another type of equipment. However, the basic method of data processing embodied in programs EMX and EMX2 should be applicable to a wide variety of situations, and it is hoped that they will be useful to most microprobe analysts who wish to use computers for data reduction.

\*\*An IBM Fortran-IV version of these programs is presently being developed by the General Atomic Division of General Dynamics, P.O. Box 608, San Diego. For a listing, contact Tom West.

## II. PROGRAM EMX

### A. Data Coding and Input

Data from the electron microprobe is read into the computer from either magnetic tape or punched cards. Each card (or tape record) contains one line of output from the probe and consists of 36 digits plus up to eight alphanumeric characters in the format described in Appendix 2. Subroutine EMXINPUT must be modified if data is to be in a different format.

The six-digit KODE\* which is part of each line of probe output is the key to this method of handling data in almost any sequence in which they happen to be run. The first, third, and fifth digits of the KODE specify the type of reading on the first, second, and third spectrometers, respectively, as follows:

- 0 = sample peak
- 1 = sample background
- 2 = standard peak
- 3 = standard background
- 4 = deadtime data

\*In this discussion, names of variables given in capital letters are the actual names used in the Fortran program.

The second, fourth, and sixth digits are the numbers assigned to the elements being considered in that reading. An element number of zero would indicate that the reading for that spectrometer should be ignored.

A special Break Card, with all zeros in the KODE column, signifies the end of a data set. This card is inserted in the data when there is a time lapse between groups of readings in the same problem. Another special card, with all nines in the KODE column, signifies the end of all data for a problem.

Data can come from the probe directly on punched cards, magnetic tape, punched paper tape, or typewritten data sheets. The best method for any particular laboratory would depend upon the type of operation and what facilities are available. We find that in most cases it is preferable to have punched cards (which are punched from our typewritten data) so that one can easily eliminate faulty data and correct operator errors. For occasional long routine projects, though, we use punched paper tape which is converted directly to magnetic tape.

Figs. 1 and 2 are examples of typewritten data sheets as they come from our microprobe. They illustrate two different types of problems: 1) analysis of six elements of a mineral and 2) analysis for a trace element preceded by a deadline determination. The comments explain the use of the KODE and possible methods of grouping data.

For oxide and oxyanion systems the amount of oxygen associated with the various elements is calculated by the computer, assuming a known specific stoichiometric relationship and in Program EMX2 these are modified as the element concentrations are modified by the correction procedure. The assignment of oxygen to a particular element is a function of its valence state and this factor (see Appendix 2) is decided by the operator and fed into the program. The program can also handle a second element (for example silicon in silicates) in like manner to oxygen.\* In pyroxene analyses, for example, Mg, Fe and Ca can be analysed simultaneously and the corresponding silicon and oxygen contents for each data point can be calculated by the computer. These components which are not experimentally measured, but determined from assumed stoichiometric relationships, are in the following referred to as "stoichiometrically determined components", abbreviated as s.d. components.

#### B. Data Processing Procedures

Data input is handled by Subroutine EMXINPUT. First a single line of data is read, and the computer uses the KODE to determine the type of data point that the reading is part of. Then any remaining readings in that data point are read. At this stage the computer checks to see that data are grouped according to the specifications on the Identification Card (see Appendix 2) for the problem and that dimension limits are not exceeded. If errors have occurred, the data cannot be processed correctly; so the computer skips over the data for that problem and goes on to the next problem, if any.

If the data point was made up of more than one reading, Subroutine EMXSUM is called to average the readings and compute the standard deviation by two methods: the root mean square (r.m.s.) and the square root of the number of counts ( $\sqrt{N}$ ). If the data point is a standard peak, it is important that the readings do not scatter over too wide a range because a large error in measured intensity of the standard would make all the analyses in the problem worthless. But when automatic data processing is used, the data may go from probe to computer without inspection. Thus the computer checks standard deviations on all standard peaks to see that the r.m.s. value does not exceed the  $\sqrt{N}$  value by more than a factor of SLIMIT. The SLIMIT factor is input with the data for each problem, and we suggest a value of 2.0 to 3.0. Setting the limit too low will cause the rejection of some good data, and setting it too high will have the effect of removing this check on data scatter.

For data points other than standard peak, the larger of the standard deviation values calculated is retained, and COUNTS are converted to counts per second. When all data for one problem have been read, control returns to the main program.

\* If s.d. components are elements other than oxygen and silicon, subroutine OXYGEN must be modified.

The TIME value output of our microprobe is the counting duration of each reading, but for the drift correction one really needs to know the time that has elapsed between the beginning of the data set and each data point. (It must be remembered that the time scale cannot continue over more than one data set because the Break Card between sets may indicate a time lapse of hours.) Therefore each data set is considered to begin at TIME = 0, and the TIME of each data point is changed to the number of seconds elapsed between the beginning of the data set and the median time of that point.

#### 1. Deadline Correction

The equation used for the deadline correction is

$$\text{COUNTS} = \frac{\text{OC}}{1.0 - \text{OC} \cdot \text{TAU}}$$

where OC = observed counts and TAU = deadline in seconds.

A value of TAU may apply only to one of the channels and may vary with time. Thus TAU values are not built into the program but must be read into the computer with data for each problem.

If TAU values are not known, they may be computed from experimental data by Program EMX, either as a separate problem or as part of any other problem. Deadline data, identified by the numeral "4" in the KODE column, consists of a set of readings on one particular substance over a wide range of sample currents. For each data point, counts per second are divided by sample current, and the resulting values are fit linearly by a least-squares method as a function of sample current,  $i_s$ . This is the equivalent of fitting the counts-per-second values with a parabola which goes through the origin, described by the formula  $Ai_s + Bi_s^2 = 0$ . Then  $\text{TAU} = -B/A^2$  sec. (Figs. 3 and 4 illustrate output from a deadline determination).

Since deadline is a function of photon energy and consequently of the elements analyzed, our first thought in writing Program EMX was to provide a simple means of recalculating TAU at frequent intervals. We soon realized, however, that to obtain a reliable value for TAU one must take many readings at many different sample currents in order to obtain adequate statistics. The current must be measured with an extremely sensitive and properly calibrated meter. Thus we have found that an occasional but thorough determination of deadline is preferable to frequent quick determinations.

Each Element Card (see Appendix 2) of the input data for Program EMX must contain information about the deadline correction to be made. TAU, if known, is entered in E format; for example, 2.0E-6 represents a deadline of  $2 \times 10^{-6}$  sec. If deadline is to be calculated from experimental data, TAU is set equal to zero. Deadline may be calculated for, say, Element 3 and then this value of TAU used also for Element 5. In this case, TAU for Element 5 would be set equal to 3.0. The computer knows that this is not an actual TAU value, because it expects the actual values to be less than one. A negative value for

TAU would indicate that no deadtime correction is to be made for that element. (We suggest that a probe analyst who chooses to regard deadtime as negligible is being overly optimistic.) If through some mischance the calculated value of TAU turns out to be negative, no deadtime correction will be made.

## 2. Drift Correction

Accurate microprobe analyses cannot be expected unless the instrument is operating in a stable manner with a minimum of drift. Program EMX corrects for drift by assuming a linear change with time between successive readings on the same standard. This correction is made with no regard to the amount of drift, and it is left to the discretion of the operator to decide whether the drift rate is low enough to justify correcting and using the data.

Successive data points on a standard were used to monitor drift during probe operation. Between each of these data points for the individual spectrometers, Program EMX corrects the data for the variation in count rate on the standard by assuming drift to be a linear function of time. The elapsed time is measured by the accumulated counting time, and the time between successive readings is assumed to be negligible. If the elapsed time between successive readings is large, a Break Card is inserted into the data at this point. Drift corrections will then be made independently for the data before and after the break. No drift correction is made in the case where the variation between successive data points on the standard is within the deviation found in the successive points. In such a case Program EMX will print out a message indicating that no drift correction has been made.

## 3. Background

Program EMX incorporates the correction for background by two alternate methods. The method most suitable for the particular problem is selected by the probe operator, and this choice indicated by the appropriate symbol for MBKGD in the lead cards to Program EMX. Background may be measured in a single set of readings for the standard and another set for the sample, and in one scheme (MBKGD = 1) these values are subtracted from each standard and sample reading for the remainder of the problem. Further background data points may be taken at any stage in the probe operation, in which case the new background values are adopted and subtracted from succeeding peak values.

For precise analytical work and particularly for the measurement of minor elements in the range 50 to 10,000 ppm it is necessary to monitor the background more carefully than can be achieved by the above method. In these cases background is measured for each data point on both sample and standard. In the second background method (MBKGD = 0) each peak value must be accompanied by a pair of background data points. The program averages these and subtracts the average value from the peak value. The sequence of background and peak values need not be kept constant (for example, see Fig. 2), but two background values must be associated with each peak value. If one background reading is omitted or an extra value included, the wrong pairs of values will be averaged.

Background values can be measured at the same wavelength as the peak values on a material similar in composition to the sample (or standard) but lacking the element being analyzed. In the absence of such material it is convenient to measure background data points at wavelengths above and below the peak wavelength. In practice, a series of data points are taken over a range of wavelengths in the neighborhood of the peak wavelength. The values of counts versus wavelength are examined to determine the variation in peak and background intensities and to search for any other emission peaks in this range. On the basis of these data, two wavelengths on either side of the peak are chosen ( $\lambda + \Delta$ ,  $\lambda - \Delta$ ) and pairs of background measurements made at these wavelengths. In the EMX program these pairs of data points are averaged to give the background values used.

## C. Output

The final printed output from Program EMX consists of a tabulation of the concentrations of elements in each sample or sample point plus a tabulation of the elements measured, combined with appropriate s.d. components, as oxides, for example (see footnote page 4). The element concentrations, of course, are the first approximations; i.e., intensity ratios times the concentration of the element in its standard. Additional printed output includes all input data; input data after readings at each data point were averaged, after deadtime correction, and after correction for drift; and the final measured x-ray intensities in counts per second with statistical errors. Figs. 5-9 are examples of printed output. Some time and paper can be saved by eliminating the intermediate output, but it is often useful to observe the effects of each correction as it is applied.

At the option of the program user, the computer will plot a graph of the concentrations (see Fig. 16). The specific plotting routines used in preparing this plot are usable only with a Calcomp 165 incremental plotter used in conjunction with CDC 3600 and CDC 160-A computers; however, it should be relatively easy for laboratories with other types of computer-plotter facilities to substitute their own plotting routines into the program.

When both programs are run together as a multiple execution job, element concentrations from EMX are written on a scratch tape for input to Program EMX2. If data is to be used for EMX2 input at some other time, it may be recorded on magnetic tape or punched cards.



### III. PROGRAM EMX2

#### A. Basic Correction Procedures

Program EMX2 uses an iterative procedure to calculate composition from the input concentrations, which are first approximations calculated from measured x-ray intensities by Program EMX. The necessary absorption and fluorescence corrections are made on the basis of the original input concentrations and a new composition obtained. This procedure is repeated as many times as specified by the program user or until the percentage change in concentrations from one iteration to the next is less than a specified amount.

The absorption correction used Philibert's

(3) formula for  $f(\chi)$ :

$$f(\chi) = \frac{1+h}{(1+\chi/\sigma)[1+h(1+\chi/\sigma)]} \quad (3)$$

where  $h = 1.2 \bar{A}/\bar{Z}$ ,  $\bar{A}$  and  $\bar{Z}$  being the mean atomic number,  $\chi = \mu/\sigma$ ,  $\bar{E}_c$  being the mass absorption coefficient of the target for the measured x-ray line and  $\theta$  being the take-off angle, and  $\sigma = \frac{2.39 \times 10^5}{E_0^{1.5} - E_c^{1.5}}$ , the effective  $\sigma$  defined by Duncumb and Shields (4),  $E_0$  being applied voltage in kv and  $E_c$  the critical excitation potential for the particular element in kv.

The fluorescence correction formula, a combination of those of Castaing (2) and Wittry (1), is as follows (in the case of Element A being fluoresced by Element B):

$$\frac{I_A^A}{I_A^B} = \frac{\omega_A \theta}{2} \cdot C_B \cdot \left( \frac{r-1}{r} \right)_A \cdot \frac{A}{B} \cdot \frac{\mu_B^A}{\mu_B^{\text{sample}}} \cdot \left[ \frac{U_B \ln U_B - U_B + 1}{U_A \ln U_A - U_A + 1} \right] \cdot \left[ \frac{\ln(1+u)}{u} + \frac{\ln(1+v)}{v} \right] \quad (4)$$

where  $I_A^A$  is the emergent primary intensity of the characteristic wavelength of element A from direct excitation,  $I_A^B$  is the emergent secondary intensity of the same wavelength from fluorescence by element B,  $\omega_B^B$  is the k-fluorescence yield,  $C_B$  is the concentration of element B,  $r$  is the absorption jump ratio, A and B are the atomic weights of elements A and B,  $\mu_B^A$  ( $\mu_{\text{sample}}^A$ ) mass absorption coefficient of the characteristic radiation of B in A (in the sample),  $E_A^A$  and  $E_B^B$  are the critical excitation potentials of elements A and B,  $U_A = E_0/E_A^A$ ,  $U_B = E_0/E_B^B$ ,  $u = \mu_{\text{sample}}^A/\mu_{\text{sample}}^B \sin \theta$  =  $\chi_A/\mu_{\text{sample}}^B$ , and  $v = \sigma/\mu_{\text{sample}}^B$ .

The basic correction formula incorporating absorption and fluorescence corrections is

$$C_A = C_A^{(1)} \frac{R_S(A)}{R} \quad (5)$$

where  $C_A^{(1)}$  is the first approximation concentration of element A,

$$C_A^{(1)} = \frac{I_A^A}{I(A)} S_A \quad (6)$$

$I(A)$  is the measured intensity of element A in its standard,  $I_A^A$  is the measured intensity of element A in the sample, and  $S_A$  is the concentration of the element in its standard. The correction factor  $R$ , which depends on the concentrations of all N elements in the sample, is given by

$$R(C_1, \dots, C_N) = F(\chi) \left( 1 + \frac{I_A^A}{I(A)} \right) \quad (7)$$

The notation  $R_S^{(A)}$  refers to the correction factor for the standard used for Element A.

In Program EMX2 Eqn. 5 is solved for the concentrations  $C_j$  by the Gauss-Seidel iteration method, which has produced rapid convergence for all cases encountered so far. The second approximation concentrations  $C_j^{(2)}$  are calculated as follows: The concentration  $C_1^{(2)}$  of element 1 is calculated using a correction factor  $R$  evaluated with the first approximation concentrations  $C_j^{(1)}$ . The concentration  $C_2^{(2)}$  of element 2 is then calculated using a correction factor  $R$  evaluated with first approximation concentrations for elements 2 through N, but with the second approximation value for  $C_1$ . The procedure continues in this manner, with  $R$  always using the best available (i.e. the most recently calculated) values for the  $C$ 's. For the second approximation this procedure is expressed by the formula

This method would be prohibitively time consuming for hand calculation, but is natural for computer calculation.

#### B. Physical Constants

Data necessary for the calculation of the various constants pertaining to absorption and fluorescence corrections involving almost any elements are stored by Subroutine CONSTANT. Below are listed the data, sources of data, and methods of calculating the required constants:

1. SINTHETA. Sine of the takeoff angle, which with our microprobe is  $52.5^\circ$ .

2. Atomic weights (A). From reports prior to 1960 of the Commission of Atomic Weights, International Union of Pure and Applied Chemistry.

3. Characteristic wavelengths (LAMBDA). For each element we have included only one characteristic wavelength, the one which we customarily use for analyzing the particular element. For elements with atomic numbers 5-35, LAMBDA is the weighted Ka wavelength (Ka<sub>1</sub> given twice the weight of Ka<sub>2</sub>); for atomic numbers 36-82, La<sub>1</sub>; and for atomic numbers 83 to 90-92, M<sub>8</sub>. Wavelength data are from Bearden (7).

4. Mass absorption coefficients (MU) are calculated by Heinrich's (5) method:  $MU = C\lambda^n$  where  $\lambda$  is the wavelength of the radiation being observed and the coefficients (C) and exponents (EXP) are those determined by Heinrich. Values for absorption edges (EDGE) are also from Heinrich's tables (5). It should be noted that the data are not complete for all elements. As of now, Program EMX2 cannot be used for the analysis of extremely light elements (atomic numbers less than 12). Values for C and EXP are also unavailable for the regions between the  $M_4$  and  $M_5$  absorption edges and beyond the  $N_1$  edge. The computer will calculate mass absorption coefficients as if the absorption curves for these regions were merely continuations of those for the  $M_3$  to  $M_4$  and  $M_5$  to  $N_1$  regions. This is a very rough approximation and will introduce greater than usual errors when analyses involve elements such that the characteristic wavelength of one falls within the unknown absorption region of the other.

5. Absorption jump ratios (R) used in the fluorescence corrections are calculated from Heinrich's data (5) by the formula  $R = (C_k/C_{k1}) \lambda_k / (\lambda_k - \lambda_{k1})$ , where C and n refer to the absorption curve of the element fluoresced and  $\lambda_k$  = the characteristic wavelength of the fluorescing element. The absorption jump ratio is commonly calculated at the absorption edge, but this unnecessary approximation is not made by Program EMX2 (see Compton and Allison(8), p. 542, or Philibert (3), p. 55).

6. K-fluorescence yields (OMEGA) are calculated from the formula

$$\left( \frac{W_k}{1 - W_k} \right) 1/4 = A + BZ + CZ^3 \quad (9)$$

using the coefficients of Hagedoorn and Wapstra(9),  $A = -0.064$ ,  $B = 0.034$ ,  $C = -1.03 \times 10^{-5}$ . Because acceptable values of the L-fluorescence yields and ratios of K to L intensities are not easily evaluated at the present time (Philibert(3))<sup>\*</sup>, only K-K fluorescence is considered. Corrections for K-L, L-K, and L-L fluorescence can be added to the program if reliable data become available.

#### C. Input

Except for the few introductory data cards (see below and Appendix 2), the input to Program EMX2 consists of the punched card or magnetic tape output from Program EMX. If no more than nine elements are involved in each problem, there will be one card (or tape record) for each sample or point on the sample, and Program EMX2 can be run with Program EMX as a multiple-execution job. For samples involving 10 to 18 different elements, however, the data must be run through the first program as two separate problems, one including nine elements and the other including the remainder. The punched card output must then be put together so that the two cards for each sample are together in the data deck for EMX2.

Sometimes samples contain elements such as carbon that cannot be analyzed directly by many micro-

probe facilities. Concentrations of such elements must be considered in the total composition, however, if absorption and fluorescence corrections are to be made. The probe operator can estimate the concentrations of elements which were not or could not be analyzed and add them to the data cards for EMX2 after the concentrations of the other elements, setting NFIX on the Identification Card (see Appendix 2) equal to the number of such elements. Concentrations of these fixed elements will be used in calculating average atomic number, etc., but will not themselves be corrected.

For a particular element i the correction factor  $R(i)$  combines the absorption and fluorescence corrections for the standard (see section IIIA). The value of  $R(i)$  depends on the composition of the standard and the operating voltage. To solve Equation 5, Program EMX2 will calculate  $R^4$  for the unknown, but the values of  $R(i)$ , the correction factors (SCF) for the elements in their standards, must be read into the program on the Element Cards (Appendix 2). Thus before any analyses of actual samples are corrected, the necessary correction factors must be calculated. This is done by considering the standard as a separate problem, with an Element Card for each element of the standard on which SCF is set equal to zero. The operating voltage (EO) for this problem is set equal to that actually used in the analyses. The computer will calculate each SCF value and punch new Element Cards containing all the necessary information including the SCF. These cards may be saved for use as Element Cards in any problem in which the same standard and EO were used. The most efficient procedure is to build up a file of Element Cards for all the standards commonly used (pure element standards as well as mineral or alloy standards) with correction factors evaluated for all EO which are likely to be used.

#### D. Computer Method

After the preliminary calculations of the physical constants (listed under Sec. IIIB, above) by Subroutine SETUP, the computer looks at the first SCF (see Sec. IIIC) to see if the correction factors for the standard are known. If they are not (i.e., if SCF = 0), the problem is assumed to be one of determining the correction factors for a particular standard. In this case the program calculates the SCF, punches new element cards, and proceeds to the next problem. If the SCF do not equal zero, the computer proceeds to the sample data and reads in the first approximation concentrations (OCON(J), J = 1 to NEL, where NEL = number of elements analyzed) for one sample or point on the sample. Subroutine OXYGEN is called to calculate the concentrations of oxygen (OCON(NELP1)) and silicon (OCON(NELP2)) (if 0 or 51 factors present) as a function of the concentrations of the other elements. Concentrations of all elements and their total are printed, and the computer then proceeds to the corrections themselves.

The first step is the storage of all OCON in CON and the multiplication of each OCON by its SCF. Now OCON is not the first approximation but a product of the first approximation and the R correction factor for the standard according to Equation

\*There is some difference of opinion about this; see Reed (10).

5. This product will remain constant throughout the iterations.

FCHI, the absorption correction factor, is calculated in Function ABSORB.

Function FLUOR(NN) calculates the fluorescence correction term, which may include the fluorescence effects of from zero to four other elements. Subroutine SETUP has previously determined which elements fluoresce each of the elements analyzed in the problem. For simplicity, the former may include only the four elements nearest in atomic number whose K $\alpha$  lines are less than the K absorption edge of the element in question. Thus, for example, in determining which elements might fluoresce Fe (Z = 26), the program looks only for elements in the problem with atomic numbers in the range 28-31. Although fluorescence by elements with higher atomic numbers or by the K $\beta$  line of Co (Z = 27) might be significant, these are not taken into consideration.

In the Fortran notation of the computer program, the function calculated by Function FLUOR(NN) is

$$FLUOR = \sum_{j=1}^{NF(NN)} CON_L \cdot U_{NN,J} \cdot \frac{ULC + V}{FMUBAR}$$

where L is index of fluorescing element, NN is index of element fluoresced, NF is number of elements fluorescing NN, FMUBAR is mass absorption coefficient of alloy for wavelength of element L, MUBAR is mass absorption coefficient of alloy for wavelength of element NN,

$$ULC = \frac{\ln(1 + MUBAR/FMUBAR \cdot \sin^2\theta)}{MUBAR/FMUBAR \cdot \sin^2\theta}$$

$$V = \frac{\ln(1 + \Sigma\sigma/FMUBAR)}{\Sigma\sigma/FMUBAR}$$

and U is the U from Subroutine SETUP, a variable which contains all the parameters of the fluorescence correction equation except those that depend on the concentrations of elements. Note: U here is not just EO/EC.

A new approximation (CON2) is then calculated according to Eqn. 8, which in Fortran notation is written as  $CON2 = OCON(I)/(FCHI*(1.0 + FL))$ . DELCON, the change in the concentration of Element 1 that resulted from this formula, is calculated; concentrations of s.d. components (if any) are modified, and the value of CON2 replaces CON(I). Then the procedure is repeated for all the other elements. Note that the estimated composition, from which FCHI and FL are calculated, changes with the correction of each element; the same estimated composition does not carry through an entire iteration. The results of each correction are printed out (see Fig. 13), and the total of concentrations is printed after each iteration.

The Limits of the iteration have been read into the computer from the Problem Card, with IMIN and IMAX specifying the minimum and maximum

number of iterations to be performed. Within these limits, the correction procedure will be iterated until DELCON for any element present in amounts greater than one percent does not change by more than DMIN from one iteration to the next.

No method for calculating estimated errors in the final results is included in the program.

## E. OUTPUT

Final output for Program EMX2 is in the same format as that from Program EMX, including the optional graph. (If more than ten elements are included in the problem, there will be two graphs because too many lines on one plot would be undecipherable.)

Concentrations in weight percent shown for each element and the total for all the elements analyzed are those calculated by the correction procedures described above. They are not normalized to sum to 100 percent. The information that the total corrected concentrations for a particular problem vary quite markedly from 100 percent can give a useful indication of how well the microprobe was working, how carefully the analyses were performed, or perhaps how the computer correction method needs to be revised. We do not believe that this valuable information should be lost.

Printed output from EMX2 begins with the input data from the Identification and Element Cards as well as all the mass absorption coefficients, wavelengths, etc., determined by Subroutine SETUP. Next comes one printed page for each sample or point on the sample showing the first approximations (those read in), and the concentrations,  $f(\lambda)$ , and fluorescence correction values calculated in each iteration, plus the change in the concentration of each element from one iteration to the next. Figs. 11 to 16 are examples of printed output from Program EMX2.

## ACKNOWLEDGMENTS

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002000	000377	028955	047217	022521	212223	Marj. ↓	Standard for Elements 1, 2 and 3 on spectrometers 1, 2 and 3, respectively. NAME indicates that the mineral standard used was Marjalahti. Identifying names are optional; this column could have been left blank.
002000	000377	028880	047936	022628	212223		
002000	000378	028897	047741	022623	212223		
002000	000378	029020	046930	022373	212223		
002000	000377	029544	047491	022558	212223		
002000	000377	029735	047164	022712	212223		
002000	000377	029771	047482	022530	212223		
002000	000377	000586	000287	000503	313233		Background readings for standard, above and below peak. Sample background readings.
002000	000377	000489	000221	000427	313233		
002000	000377	000717	000249	000089	111213		
002000	000377	000868	000327	000081	111213		
002000	000377	034633	038649	000116	010203	1 2 3 A 3 B 3 C	Sample readings on all three spectrometers.  Standard readings repeated. Computer will interpolate between this and previous group of standard readings to correct for drift.
002000	000377	036125	041653	000138	010203		
002000	000377	038196	042098	000141	010203		
002000	000377	036543	039488	000147	010203		
002000	000377	046622	040533	000110	010203		
002000	000377	028242	046361	022460	212223		
002000	000377	038824	046663	022570	212223	Marj. ↓	"BREAK" Card: indicates end of a data set.
002000	000377	028525	046817	022492	212223		
					000000		
002000	000377	000164	070293	019544	202526	andesine ↓	Standard peak for elements 5 and 6 on spectrometers 2 and 3, respectively. Zero in the second column of the KODE indicates that reading on spectrometer 1 is to be ignored.
002000	000377	000154	070625	019317	202526		
002000	000377	000161	069911	019636	202526		
002000	000300	201090	002560	000164	240000	Min 100 ↓	Standard for Element 4 on spectrometer 1; other spectrometers ignored.  First sample background reading. Will be averaged with the one that comes after the sample readings. Note that pairs of background readings need not appear consecutively.
002000	000300	201295	002524	000162	240000		
002000	000300	200767	002709	000142	240000		
002000	000300	202077	002612	000181	240000		
002000	000300	202517	002538	000171	240000		
002000	000350	000493	000149	000187	141516		
002000	000350	045393	013670	012138	040506	1 2 3 A 3 B 3 C	
002000	000350	043481	012899	012285	040506		
002000	000350	044873	012964	012301	040506		
002000	000350	042892	013854	012355	040506		
002000	000350	037200	018717	012266	040506		
002000	000350	000508	001631	000279	141516		
002000	000300	001529	002530	000137	340000		
002000	000300	001717	002619	000146	340000		
002000	000300	200927	002689	000120	240000	Min 100 ↓	
002000	000300	200519	000298	000161	240000		
002000	000377	000263	069380	019736	003536	andesine ↓	
002000	000377	000234	069246	019154	003536		
					999999		Card signalling the end of the data for this problem.

Figure 1. Data sheet as it comes from the microprobe illustrating the use of the six-digit code. The columns, from left to right, are counting time in hundredths of a second, sample current in  $\mu\text{A} \times 10^{-4}$ , counts on spectrometers 1, 2 and 3, the six-digit code (KODE), and, if desired, a name for identification (NAME). In this problem NS = 1, so each reading on the sample is a separate data point. MBKGD = 1 so background data points do not accompany each individual peak data point.

000100	000800	003837	000000	000000	410000	Deadtime data on Spectrometer 1. Printout columns for spectrometers 2 and 3 were not used, so turned off. NDT = 1, so each reading is one data point. Of course many more dead time data points would be taken.
001000	000780	003712	000000	000000	410000	
001000	000760	003654	000000	000000	410000	
000000	000013	000476	000000	000000	000000	"BREAK" Card. Numbers which happened to get printed in cols. 2 and 3 will be ignored.
002000	000000	000374	000000	000000	310000	Standard peak and background readings. For this problem NS was set equal to 2, so standard background, sample background, and sample peak data points will be taken in pairs which will be averaged. Note that readings in this problem were taken over different time intervals.
002000	000000	000384	000000	000000	310000	
002000	000000	120118	000000	000000	210000	
002000	000000	119402	000000	000000	210000	
002000	000000	120751	000000	000000	210000	
002000	000000	121284	000000	000000	210000	
002000	000000	000391	000000	000000	310000	
002000	000000	000397	000000	000000	310000	
010000	000000	000699	000000	000000	110000	First sample. MBKGD equals 0, so a pair of background data points will be taken with each sample.
010000	000000	000690	000000	000000	110000	
010000	000000	000568	000000	000000	110000	
010000	000000	000551	000000	000000	110000	
010000	000000	000695	000000	000000	010000	
010000	000000	000688	000000	000000	010000	
010000	000000	000669	000000	000000	010000	
010000	000000	000669	000000	000000	010000	
010000	000000	000696	000000	000000	110000	Second sample. Note that background points were taken before the first sample but after this sample. Computer will keep track of which background goes with which sample.
010000	000000	000700	000000	000000	110000	
010000	000000	000591	000000	000000	110000	
010000	000000	000585	000000	000000	110000	
002000	000000	117977	000000	000000	210000	
002000	000000	118404	000000	000000	210000	
002000	000000	117931	000000	000000	210000	
002000	000000	118216	000000	000000	210000	
010000	000000	000692	000000	000000	110000	A standard peak data point taken again to check for drift. Because MBKGD equals 0 but no background readings were taken for this standard peak, this data point will not be corrected for background. But that doesn't matter because this point is used only for the drift correction.
010000	000000	000681	000000	000000	110000	
010000	000000	000708	000000	000000	010000	
010000	000000	000721	000000	000000	010000	
010000	000000	000501	000000	000000	110000	
010000	000000	000519	000000	000000	110000	
000000	000000	000000	000000	000000	999999	

Figure 2. Data as it comes from the microprobe illustrating the use of the six-digit code. First three readings are part of a data set used to measure deadtime. The remaining readings refer to a problem in which NS = 2 so that each standard background, sample peak and sample background data point comprises two readings which will be averaged. MBKGD = 0, so each peak data point is accompanied by a pair of background data points.

DEADTIME 12/22/65 ARCH LUDLOW

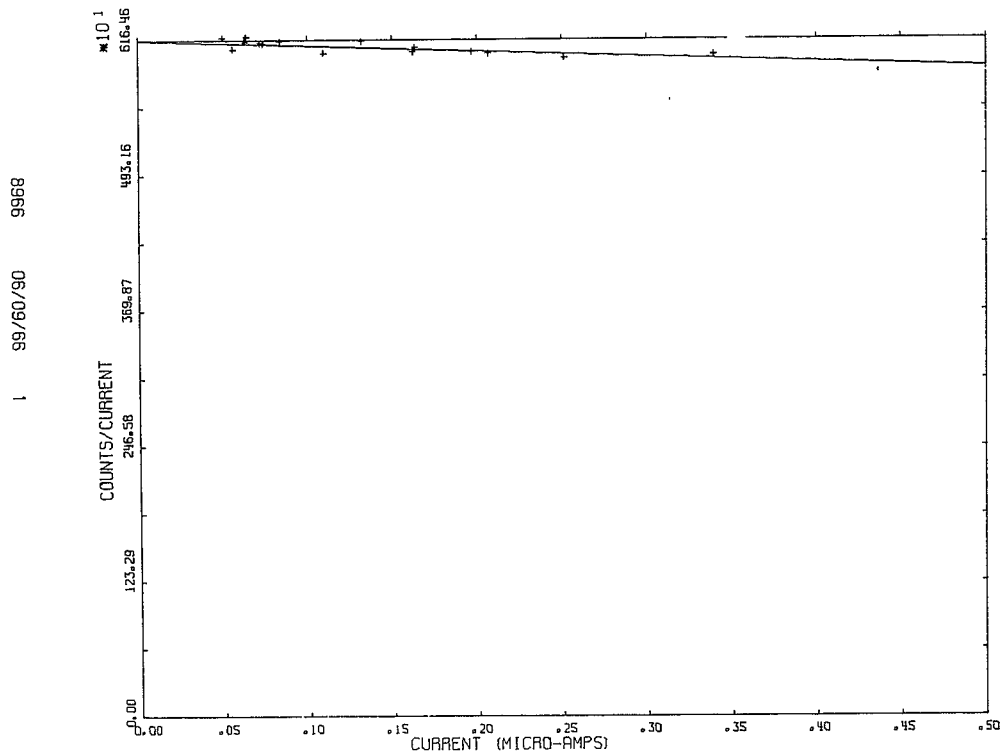


Figure 3. Sample of the type of plot drawn by the computer for deadtime data points. Counting rate divided by sample current is plotted against sample current. If there were no deadtime the points would plot on a horizontal straight line. The slope of the line (least squares fit to the plotted points) is a measure of the deadtime. The equation of the line is used to derive the constants for the parabola approximated in a plot of counting rate versus sample current, and hence to estimate the deadtime (Section IIB).

COEFFICIENTS OF  $Y=B_1+B_2 \cdot X+ETC$  AND ERRORS

B( 1)= 5.7233994E 02 ERRB= 2.517E 00 B( 2)= -1.5635789F 00 ERRE= 1.211F 00 B(

SIGMA = 1.3125602E 00

COEFFICIENTS OF  $\dot{Y}=T_1 \cdot P_1+T_2 \cdot P_2+ETC$  AND ERRORS

T( 1)= 5.6942390E 02 ERPT= 1.110E 00 T( 2)= -1.5635789F 00 ERRT= 1.211F 00 T(

I	X(I)	F(I)	Y(I)	DELY(I)	W(I)
1	4.9885000E-01	5.7572417E 02	5.7155995E 02	-4.1642160E 00	3.4658959E-02
2	5.6215000E-01	5.6755314E 02	5.7146098E 02	3.9078309E 00	3.9619197E-02
3	6.4215000E-01	5.7899245E 02	5.7133589E 02	-7.6565585E 00	4.4363273E-02
4	7.3995000E-01	5.7368741E 02	5.7118297E 02	-2.5044406E 00	5.1592556E-02
5	6.3105000E-01	5.7745028E 02	5.7135324E 02	-6.0970368E 00	4.3712854E-02
6	7.2105000E-01	5.6632688E 02	5.7121252E 02	4.8856380E 00	5.0227084E-02
7	8.3880000E-01	5.7319981E 02	5.7102841E 02	-2.1713983E 00	5.8534562E-02
8	1.0954500E 00	5.7223059E 02	5.7062212E 02	-1.6034717E 00	5.1148626E-02
9	1.3187500E 00	5.6693839E 02	5.7027797E 02	3.3395826E 00	9.3043620E-02
10	1.6354000E 00	5.7161856E 02	5.6978286E 02	-1.8357003E 00	1.1443995E-01
11	2.0698000E 00	5.7289352E 02	5.6910365E 02	-3.7898709E 00	1.4451551E-01
12	1.6243000E 00	5.6769070E 02	5.6980022E 02	2.1095222E 00	1.1444965E-01
13	1.9687000E 00	5.6100472E 02	5.6926172E 02	8.2569992E 00	1.4036958E-01
14	2.5175500E 00	5.6699966E 02	5.6840355E 02	1.4038905E 00	1.7760504E-01
15	3.3996500E 00	5.6917624E 02	5.6702432E 02	-2.1519188E 00	2.3891721E-01

FOR ELEMENT 12 ON SPECTROMETER 3,  $\tau = 4.77E-06$  SECONDS

Figure 4. Output of deadtime calculation from Program EMX.



PROBLEM NO. 18 SP55SARTINE RUTHERFORD PEGMATITE ARCH MAR 1966

NO. OF ELEMENTS = 5

0 DEADTIME READINGS PER SET

2 SAMPLE READINGS PER SET

BACKGROUND READING METHOD = 1

SIGMA FOR STANDARD PEAK MAY NOT EXCEED  $3.0 * \text{SQRT}(N)$

ELEMENT	ATOMIC NUMBER	PER CENT W OF STANDARD	TAJ	OXYGEN FACTOR	SILICON FACTOR	
1	25	34.970000	1.60E-05	.29110	-0	MNO
2	20	6.980000	2.00E-06	.39220	-0	CAO
3	13	14.700000	2.00E-06	.88260	-0	AL2O3
4	26	8.700000	1.60E-05	.28650	-0	FE0
5	14	18.800000	2.00E-06	1.13200	-0	SiO2

Figure 5. Output from Program EMX. First output page showing problem description.

PROBLEM NO. 18 SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966

	NAME	TIME	INPUT DATA CURRENT	SPEC 1	SPEC 2	SPEC 3	CODE
1		20.00	0	82609	27242	53	210000
1		20.00	0	83333	27554	59	210000
1		20.00	0	81919	27580	54	210000
1		20.00	0	82353	27778	62	210000
1		20.00	0	82898	27674	67	210000
2		20.00	0	295	60848	18813	202223
2		20.00	0	280	60669	18580	202223
2		20.00	0	287	60744	18685	202223
2		20.00	0	313	60603	18996	202223
2		20.00	0	287	59902	18594	202223
3		20.00	0	45685	11379	11872	010203
3		20.00	0	45679	11379	11649	010203
4		20.00	0	45231	11307	11789	010203
4		20.00	0	45221	11314	11820	010203
5		20.00	0	44891	10515	11886	010203
5		20.00	0	45595	10525	11974	010203
6		20.00	0	44192	12028	11876	010203
6		20.00	0	44215	12215	11977	010203
7		20.00	0	45040	12840	11905	010203
7		20.00	0	45022	12616	11756	010203
8		20.00	0	39273	14946	11825	010203
8		20.00	0	38805	15069	11828	010203
9		20.00	0	44900	12495	11831	010203
9		20.00	0	44371	12478	11799	010203
10		20.00	0	46359	11800	12004	010203
10		20.00	0	46724	11691	11951	010203
11		20.00	0	45120	12941	11895	010203
11		20.00	0	45004	12911	11780	010203
12		20.00	0	52604	10574	11695	010203
12		20.00	0	52448	10457	11767	010203
13		20.00	0	270	61696	18608	202223
13		20.00	0	302	60964	18678	202223
14		20.00	0	81351	27847	76	212020
14		20.00	0	80984	27808	51	212020
15		20.00	0	45272	11313	11930	010203
15		20.00	0	45801	11459	11604	010203
16		20.00	0	54102	10271	11781	010203
16		20.00	0	54381	10070	11926	010203
17		20.00	0	52073	10510	11930	010203
17		20.00	0	51502	10468	11615	010203
18		20.00	0	52731	10313	11464	010203
18		20.00	0	52212	10341	11826	010203
19		20.00	0	52819	8888	11689	010203
19		20.00	0	53108	9048	11855	010203
20		20.00	0	52501	10685	11628	010203

Figure 6. Output from Program EMX. Second output page showing raw probe data and code identification of data points.

## AVERAGED DATA

REL. TIME	CURRENT	SPECTROMETER 1		SPECTROMETER 2		SPECTROMETER 3	
		CTS/SEC	SIGMA	CTS/SEC	SIGMA	CTS/SEC	SIGMA
1	50	0	4131.1	10.7	2 1	0	0 0 0
2	150	0	2284.1	7.6	0 1	3627.7	7.5 2 2
3	220	0	2261.3	7.5	0 1	565.5	3.8 0 2
4	260	0	2262.2	12.4	0 1	524.0	3.6 0 2
5	300	0	2210.2	7.4	0 1	604.1	3.9 0 2
6	340	0	2251.6	7.5	0 1	636.4	4.0 0 2
7	380	0	1951.9	8.3	0 1	750.4	4.3 0 2
8	420	0	2231.8	9.4	0 1	624.3	4.0 0 2
9	460	0	2327.1	7.6	0 1	587.3	3.8 0 2
10	500	0	2253.1	7.5	0 1	646.3	4.0 0 2
11	540	0	2626.3	8.1	0 1	525.8	3.6 0 2
12	580	0	0	0	2 1	3064.5	12.9 2 2
13	620	0	4058.4	10.1	2 1	0	0 2 0
14	660	0	2276.8	9.4	0 1	569.3	3.8 0 2
15	700	0	2712.1	8.2	0 1	508.5	3.6 0 2
16	740	0	2589.4	10.1	0 1	324.5	3.6 0 2
17	780	0	2623.6	9.2	0 1	516.4	3.6 0 2
18	820	0	2648.2	8.1	0 1	444.4	3.3 0 2
19	860	0	2622.5	8.1	0 1	532.3	3.6 0 2
20	900	0	2735.7	8.3	0 1	515.7	3.6 0 2
21	940	0	2670.5	8.2	0 1	510.4	5.4 0 2
22	980	0	2650.7	17.0	0 1	472.5	3.4 0 2
23	1020	0	2995.2	14.6	0 1	417.4	3.5 0 2
24	1060	0	0	0	2 1	2954.7	8.6 2 2
25	1100	0	3939.9	10.4	2 1	0	0 2 0
26	1140	0	37.8	1.0	3 1	0	0 0 0
27	1180	0	37.5	0.9	3 1	0	0 0 0
28	1220	0	0	0	3 0	64.7	1.3 3 2
29	1260	0	0	0	3 0	64.5	1.3 3 2
30	1300	0	25.7	0.8	1 1	71.6	1.4 1 2
31	1340	0	25.9	1.3	1 1	64.7	1.3 1 2
32	1380	0	4156.3	10.2	2 1	0	0 2 0
33	20	0	0	0	2 1	3101.6	8.8 2 2
34	60	0	3066.5	8.8	0 1	447.4	5.9 0 2
35	100	0	3212.4	10.8	0 1	418.1	3.2 0 2
36	140	0	3421.5	8.7	0 1	467.3	4.8 0 2
37	180	0	3139.2	8.9	0 1	427.7	3.3 0 2
38	220	0	2972.4	8.6	0 1	464.5	3.4 0 2
39	260	0	3306.7	21.8	0 1	374.0	3.1 0 2
40	300	0	1342.1	9.1	0 1	384.4	3.1 0 2
41	340	0	3297.2	9.0	0 1	394.6	3.1 0 2
42	380	0	3215.5	9.0	0 1	383.1	3.1 0 2
43	420	0	3249.6	9.0	0 1	349.1	3.0 0 2
44	460	0	0	0	2 1	3033.1	8.7 2 2
45	500	0	4134.7	10.2	2 1	0	0 2 0
46	540	0	3220.5	19.4	0 1	349.3	3.0 0 2
47	580	0	0	0	2 0	0	0 2 0

Figure 7. Output from Program EMX. Averaged data. Columns from left to right are data point number, relative time (for drift correction), sample current (not measured in this problem), averaged count rate in counts per second for each data point on spectrometer 1, error, code number showing type of reading, element number, averaged count rate on spectrometer 2, etc.

PROBLEM NO. 18 SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966  
CONCENTRATIONS CORRECTED FOR DEADTIME, DRIFT, AND BACKGROUND

E	SAMPLE	SAMPLE CURRENT	CORRECTED CTS/SEC	CONCENTRATION	RELATIVE ERROR	GROUND
1 1	STD	0	4388.3	.34970	.002	
3 1		0	2357.8	.18789	.004	
4 1		0	2336.1	.18616	.004	
5 1		0	2339.9	.18647	.006	
6 1		0	2286.5	.18221	.004	
7 1		0	2334.3	.18602	.004	
8 1		0	2012.7	.16039	.005	
9 1		0	2318.7	.18477	.005	
10 1		0	2425.7	.19330	.004	
11 1		0	2347.8	.18710	.004	
12 1		0	2761.7	.22007	.004	
15 1		0	2343.6	.18676	.005	
16 1		0	2824.5	.22508	.004	
17 1		0	2697.1	.21493	.004	
18 1		0	2741.8	.21849	.004	
19 1		0	2776.3	.22124	.004	
20 1		0	2755.2	.21926	.004	
21 1		0	2888.5	.23018	.004	
22 1		0	2823.5	.22500	.004	
23 1		0	2808.9	.22384	.004	
24 1		0	3204.4	.25535	.005	
2 2	STD	0	2979.5	.05980	.003	
3 2		0	498.3	.01167	.008	
4 2		0	494.3	.01158	.008	
5 2		0	454.2	.01064	.009	
6 2		0	533.5	.01250	.008	
7 2		0	563.1	.01319	.008	
8 2		0	675.8	.01583	.007	
9 2		0	549.7	.01288	.008	
10 2		0	512.2	.01200	.008	
11 2		0	570.1	.01336	.008	
12 2		0	450.0	.01054	.009	
15 2		0	499.8	.01171	.008	
16 2		0	438.9	.01028	.009	
17 2		0	454.8	.01066	.009	
18 2		0	446.7	.01047	.009	
19 2		0	378.6	.00887	.010	
20 2		0	462.7	.01084	.009	
21 2		0	447.1	.01047	.009	
22 2		0	440.8	.01033	.013	
23 2		0	402.7	.00943	.009	
24 2		0	347.5	.00814	.011	

Figure 8. Output from Program EMX. First approximation. Columns from left to right are data point number, element number, sample current, count rate in counts per second corrected for deadtime, drift and background, corresponding composition (first approximation) and statistical error.

PROBLEM NO.	18	SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966				
CONCENTRATIONS CORRECTED FOR DEADTIME, DRIFT, AND BACK GROUND						
TOTAL	25	20	13	26	14	
55.1833	18.7891	1.1674	9.2061	8.8023	17.2184	
56.5262	18.6158	1.1580	9.2412	10.1431	17.3682	
56.6706	18.6466	1.0641	9.3413	10.3872	17.2315	
57.3713	18.2205	1.2498	9.3385	11.2715	17.2909	
57.0652	18.6017	1.3190	9.2619	10.6624	17.2201	
58.3307	16.0391	1.5832	9.2587	14.0259	17.4238	
57.8720	18.4771	1.2877	9.2495	11.4579	17.3998	
58.2862	19.3300	1.1999	9.3792	11.1632	17.2139	
58.2711	18.7095	1.3356	9.2675	11.5483	17.4102	
57.0318	22.0074	1.0543	9.1825	7.4855	17.3021	
57.2659	18.6760	1.1708	9.2112	10.6452	17.5625	
58.0152	22.5078	1.0281	9.2803	7.6470	17.5519	
57.6675	21.4926	1.0655	9.2156	8.3213	17.5724	
57.3793	21.8494	1.0465	9.1139	7.7834	17.5860	
57.0401	22.1240	.8870	9.2152	7.3558	17.4581	
57.9029	21.9561	1.0840	9.0600	8.2380	17.5648	
58.2234	23.0179	1.0474	9.0991	7.4067	17.6523	
57.4976	22.4998	1.0326	9.0947	7.4176	17.4529	
57.2470	22.3940	.9435	8.9834	7.3607	17.5754	
57.8181	25.5354	.8142	9.1043	4.6985	17.6657	
58.4975	25.3499	.8650	9.4608	5.1888	17.6330	
59.0397	26.6425	.7999	9.3045	4.5568	17.7360	
59.0839	24.9774	.9150	9.4385	6.0359	17.7171	
58.7357	26.0216	.8144	9.3422	5.0292	17.5282	
58.7214	24.5735	.9129	9.3518	6.2747	17.6085	
59.0574	27.5203	.7055	9.4517	3.6528	17.7271	
59.0784	27.8477	.7315	9.4180	3.4825	17.5988	
58.1192	26.6658	.7570	9.3182	3.9613	17.4169	
57.7727	26.7513	.7319	9.3055	3.7337	17.2503	
56.9297	27.0546	.6544	9.1388	2.8657	17.2062	
57.0592	26.7337	.6362	9.1823	3.0256	17.4313	
56.8160	27.8768	.5787	9.0779	2.0738	17.2087	
56.4300	26.0319	.6555	9.2305	3.1105	17.4015	
56.2167	27.3320	.5705	9.0234	2.0134	17.2773	
56.2717	26.7507	.5634	8.8692	2.8402	17.2483	
56.4949	27.5216	.4786	9.0119	1.9081	17.5747	
56.2432	28.7223	.4996	8.9815	.8430	17.1969	
57.1427	27.2230	.6346	9.0060	2.7017	17.5774	
57.0323	26.8648	.6313	8.9811	3.2180	17.3371	
56.9173	28.5053	.4643	9.0080	1.2703	17.6694	

Figure 9. Output from Program EMX. First approximation. Concentrations in weight percent, elements identified by atomic number.

PROBLEM NO. 18

SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966

CONCENTRATIONS CORRECTED FOR DEADTIME, DRIFT, AND BACKGROUND

TOTAL	MNO	CAO	AL2O3	FEO	SiO2
91.4341	24.2386	1.6253	17.3958	11.3241	36.8302
93.3087	24.0348	1.6121	17.4621	13.0490	37.1505
93.4286	24.0746	1.4815	17.6513	13.3631	36.8581
94.3966	23.5245	1.7400	17.6461	14.5008	36.9853
93.9054	24.0167	1.8364	17.5013	13.7171	36.8339
95.7213	20.7081	2.2041	17.4953	18.0443	37.2695
95.0851	23.8557	1.7927	17.4779	14.7406	37.2182
95.5324	24.9570	1.6705	17.7230	14.3614	36.8205
95.6244	24.1559	1.8594	17.5119	14.8568	37.2404
93.8720	28.4137	1.4677	17.3513	9.6301	37.0092
94.4096	24.1126	1.6300	17.4056	13.6951	37.5663
95.4088	29.0599	1.4314	17.5360	9.8379	37.5436
94.9392	27.7491	1.4834	17.4139	10.7053	37.5875
94.5182	28.2098	1.4570	17.2216	10.0134	37.6164
94.0183	28.5643	1.2349	17.4131	9.4632	37.3428
95.1457	28.3475	1.5092	17.1198	10.5981	37.5710
95.6573	29.7184	1.4582	17.1937	9.5288	37.7582
94.5470	29.0495	1.4376	17.1854	9.5427	37.3317
94.2519	28.8999	1.3135	16.9751	9.4695	37.5938
95.1373	32.9688	1.1335	17.2035	6.0446	37.7869
96.2030	32.7292	1.2042	17.8771	6.6754	37.7170
96.8932	34.3981	1.1136	17.5818	5.8623	37.9374
97.0193	32.2484	1.2738	17.8350	7.7651	37.8970
96.3463	33.5965	1.1338	17.6531	6.4701	37.4929
96.4060	31.7268	1.2709	17.6712	8.0724	37.6646
96.9912	35.5314	.9822	17.8599	4.6993	37.9184
96.8927	35.9541	1.0183	17.7963	4.4802	37.6438
95.4407	34.4282	1.0539	17.6077	5.0962	37.2547
94.8430	34.5386	1.0190	17.5836	4.8033	36.8984
93.6136	34.9430	.9111	17.2687	3.6868	36.8041
93.9952	34.5805	.8858	17.3509	3.8925	37.2856
93.4285	35.9918	.8057	17.1537	2.6679	36.8094
93.1880	33.6098	.9126	17.4420	4.0017	37.2219
92.6797	35.2884	.7943	17.0506	2.5903	36.9562
92.6294	34.5378	.7843	16.7592	3.6539	36.8942
93.2753	35.5331	.6664	17.0289	2.4548	37.5922
92.6188	37.0833	.6955	16.9714	1.0845	36.7841
94.1226	35.1476	.8835	17.0177	3.4758	37.5981
93.7587	34.6851	.8789	16.9706	4.1400	37.0840
93.9003	36.8032	.6465	17.0214	1.6342	37.7949
94.6211	34.2531	.9794	17.7184	4.6581	37.0121
94.7495	37.0218	.7655	17.6435	1.4096	37.9090
95.6673	38.5120	.6120	17.8083	.9866	37.7484
94.8211	37.6485	.7903	17.8053	1.2288	37.3481
95.7229	37.9347	.7728	17.9946	1.2009	37.8199

Figure 10. Output from Program EMX. First approximation. Concentrations in weight percent, expressed as oxides.

PROBLEM NO. 18 SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966

20 KV

NL	Z	-----STANDARD FOR ELEMENT Z----- CONCENTRATION	F(CHI)+(1+FLUOR)	OXYGEN FACTOR	SILICON FACTOR	
1	25	,349690	,964476	,291100	-0	MNO
2	20	,069800	,874575	,399200	-0	CAO
3	13	,147000	,599711	,889600	-0	AL2O3
4	26	,087000	,974452	,286500	-0	FE0
5	14	,188000	,528008	1,139000	-0	SiO2

## MASS ABSORPTION COEFFICIENTS---MU/RHO

EMITTER=	25	20	13	26	14
ABSORBER					
25	79	286	3419	84	2225
20	371	139	1669	296	1086
13	117	432	386	93	3493
26	89	321	3844	71	2502
14	145	531	504	115	328
8	31	116	1505	25	966

Figure 11. Output from Program EMX2. First output page showing for each element an identifying number, atomic number, concentration of the element in its standard, the correction factor (R) for the 20 kv operating voltage (see Section IIIA), oxygen factor, silicon factor, and formula of the oxide. Calculated mass absorption coefficients are shown in the lower table.

NL	Z	NUMBER OF FLUORESCING ELEMENTS	ELEMENT NUMBER AND ABSORPTION JUMP RATIO OF FLUORESCING ELEMENTS
1	25	0	
2	20	0	
3	13	1	5 13,902
4	26	0	
5	14	0	
6	8	0	

Z	LAMBDA	EC	SIGMA	OMEGA	U
25	2,1020	6,539	3286,5	,2600	3,059
20	3,3590	4,038	2938,7	,1201	4,953
13	8,3400	1,559	2731,6	,0195	12,827
26	1,9370	7,113	3391,4	,2925	2,812
14	7,1260	1,838	2748,7	,0273	10,881
8	~0	,827	2694,7	,0018	24,198

LAMBDA = WAVELENGTH OF EMISSION LINE  
 Z = ATOMIC NUMBER  
 R = ABSORPTION JUMP RATIO  
 EC = CRITICAL EXCITATION VOLTAGE (KV)  
 OMEGA = K FLUORESCENCE YIELD  
 U = EO/EC

Figure 12. Output from Program EMX2. Table showing what elements will fluoresce what other elements and the calculated values of the parameters required for the corrections.



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20 K

NIT	Z	CON	DELCON	F(CH1)	I/I(FL)
0	25	.278500			
0	20	.007315			
0	13	.094180			
0	26	.034820			
0	14	.176000			
0	8	.378214			
0	TOT	.969029			
1	25	.277636	-.000864	.967478	0
1	20	.007258	-.000057	.881503	0
1	13	.115107	.020927	.488548	.004368
1	26	.034843	.000023	.973821	0
1	14	.175498	-.000502	.529520	0
1	8	.395990			
1	TOT	1.006330			
2	25	.277947	.000311	.966396	0
2	20	.007290	.000032	.877580	0
2	13	.116129	.001023	.484339	.004176
2	26	.034844	.000001	.973792	0
2	14	.175743	.000245	.528780	0
2	8	.397283			
2	TOT	1.009235			
3	25	.277972	.000025	.966309	0
3	20	.007292	.000002	.877322	0
3	13	.116197	.000067	.484059	.004172
3	26	.034844	.000001	.973775	0
3	14	.175776	.000033	.528680	0
3	8	.397389			
3	TOT	1.009470			

Figure 13. Output from Program EMX2. Correction of a single data point. Columns from left to right are the number of iterations, atomic number, concentration, the change in concentration from the previous estimate, the absorption correction factor and the fluorescence correction factor. Output from EMX gives the first estimate, and three successive iterations are shown.

PROBLEM NO.,	18	SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966				20 KV
CONCENTRATIONS CORRECTED FOR ABSORPTION AND FLUORESCENCE						
TOTAL	25	20	13	26	14	8
93.3768	18.7288	1.1547	10.9273	8.7990	16.6490	37.1180
96.1455	18.5739	1.1493	11.1592	10.1428	17.0273	38.0929
96.5022	18.6034	1.0564	11.3131	10.3927	16.9508	38.1858
97.8950	18.1859	1.2428	11.4043	11.2786	17.1186	38.6648
97.1211	18.5622	1.3101	11.2639	10.6667	16.9777	38.3404
99.8837	16.0280	1.5777	11.4635	14.0524	17.4111	39.3509
98.8205	18.4510	1.2818	11.3624	11.4714	17.2868	38.9671
99.6544	19.3027	1.1954	11.5879	11.1720	17.1999	39.1963
99.6049	18.6856	1.3306	11.4349	11.5640	17.3604	39.2295
96.8116	21.9537	1.0463	11.1276	7.4876	16.9910	38.2055
97.6590	18.6423	1.1641	11.2189	10.6568	17.3221	38.6548
98.9539	22.4654	1.0229	11.3598	7.6522	17.3949	39.0588
98.2569	21.4451	1.0600	11.2451	8.3259	17.3567	38.8241
97.5696	21.7993	1.0403	11.0804	7.7861	17.3046	38.5588
96.9564	22.0603	.8808	11.1623	7.3568	17.1506	38.3456
98.4979	21.9154	1.0781	11.0927	8.2432	17.3580	38.8105
99.1520	22.9757	1.0419	11.1640	7.4123	17.4843	39.0738
97.6577	22.4470	1.0264	11.0772	7.4208	17.1865	38.4998
97.1199	22.3219	.9370	10.9100	7.3624	17.2519	38.3367
98.2413	25.4750	.8093	11.0863	4.6991	17.4026	38.7691
99.9853	25.2997	.8614	11.6012	5.1925	17.5380	39.4925
100.8515	26.5903	.7972	11.4786	4.5805	17.6944	39.7305
101.2307	24.9433	.9127	11.6692	6.0422	17.7306	39.9326
100.2285	25.9574	.8111	11.5013	5.0323	17.4663	39.4503
100.3386	24.5256	.9095	11.5202	6.2801	17.5563	39.5468
101.0406	27.4585	.7035	11.6526	3.6556	17.7046	39.8559
100.9470	27.7972	.7292	11.6197	3.4844	17.5776	39.7389
98.9010	26.6034	.7529	11.3837	3.9621	17.2473	38.9516
98.1012	26.8759	.7272	11.3295	3.7342	17.0314	38.6030
96.2212	26.9678	.6489	11.0179	2.8647	16.8257	37.8961
96.6407	26.6923	.6313	11.0732	3.0250	17.0544	38.1645
95.8910	27.7789	.5736	10.9251	2.0727	16.7894	37.7513
95.4990	25.9379	.6497	11.0479	3.1093	16.9357	37.8186
94.7149	27.2225	.5848	10.7778	2.0112	16.7482	37.3903
94.6782	26.6446	.5578	10.6243	2.8375	16.7231	37.2908
95.3665	27.4145	.4743	10.7855	1.9065	17.0524	37.7333
94.5974	28.8018	.4945	10.7242	.8421	16.6573	37.2775
96.6447	27.1306	.6296	10.8672	2.7010	17.1696	38.1466
96.3126	26.7688	.6261	10.8474	3.2166	16.9424	37.9112
96.1899	28.4059	.4605	10.8219	1.2692	17.1991	38.0333
97.7583	26.4536	.6988	11.3771	3.6209	17.0500	38.5580
97.4588	28.5788	.5460	11.2490	1.0957	17.3591	38.6303
98.9293	29.7418	.4372	11.4558	.7668	17.4308	39.0969
97.7847	29.0691	.5638	11.3884	.9550	17.1653	38.6431
98.9956	29.2985	.5521	11.5592	.9335	17.4626	39.1896

Figure 14. Output from Program EMX2. Concentrations in weight percent identified by atomic number after correction for absorption and fluorescence.

PROBLEM NO. 18

SPESSARTINE RUTHERFORD PEGMATITE ARCH MAR 1966

20 KV

## CONCENTRATIONS CORRECTED FOR ABSORPTION AND FLUORESCENCE

TOTAL WND	CAO	AL2O3	FE0	SIO2
93.3768	24.1808	1.6157	20.6482	11.3199
96.1455	23.9808	1.6081	21.0864	13.0488
96.5022	24.0189	1.4781	21.3772	13.3703
97.8950	23.4798	1.7390	21.5496	14.5099
97.1211	23.9557	1.8331	21.2843	13.7228
99.8837	20.6938	2.2076	21.6615	18.0784
98.8205	23.8220	1.7935	21.4704	14.7580
99.6544	24.9218	1.6727	21.8966	14.3728
99.6049	24.1249	1.8617	21.6073	14.8770
96.8116	28.3444	1.4640	21.0267	9.6328
97.6590	24.0690	1.6288	21.1992	13.7100
98.9539	29.0051	1.4312	21.4654	9.8445
98.2569	27.6878	1.4832	21.2487	10.7112
97.5698	28.1451	1.4556	20.9375	10.0169
96.9564	28.4821	1.2325	21.0922	9.4645
98.4979	28.2950	1.5084	20.9608	10.6049
99.1520	29.6640	1.4578	21.0954	9.5360
97.6577	28.9813	1.4361	20.9314	9.5469
97.1199	28.8198	1.3111	20.6156	9.4717
98.2413	32.8907	1.1324	20.9486	6.0453
99.9853	32.6645	1.2053	21.9216	6.6802
100.8515	34.3307	1.1155	21.6899	5.8671
101.2307	32.2043	1.2771	22.0502	7.7733
100.2286	33.5265	1.1350	21.7328	6.4740
100.3386	31.6550	1.2726	21.7686	8.0794
101.0406	35.4646	.9843	22.0187	4.7029
100.9470	35.8889	1.0203	21.9565	4.4827
98.9010	34.3477	1.0534	21.5107	5.0972
98.1012	34.4412	1.0175	21.4083	4.8041
96.2212	34.8181	.9080	20.8195	3.6854
96.6407	34.4625	.8833	20.9239	3.8916
95.8910	35.8654	.8026	20.6441	2.6665
95.4990	33.4884	.9090	20.8761	4.0001
94.7149	35.1470	.7903	20.3657	2.5875
94.6782	34.4009	.7805	20.0757	3.6505
95.3665	35.3949	.6636	20.3802	2.4527
94.5974	36.9277	.6919	20.2644	1.0834
96.6447	35.0284	.8810	20.5347	3.4749
96.3126	34.5512	.8761	20.4973	4.1381
96.1899	36.6749	.6443	20.4490	1.6328
97.7583	34.1542	.9778	21.4982	4.6583
97.4588	36.8981	.7639	21.2561	1.4096
98.9293	38.3997	.6117	21.6470	.9865
97.7847	37.5311	.7889	21.5196	1.2286
98.9956	37.8273	.7725	21.8423	1.2010

Figure 15. Output from Program EMX2. Concentrations expressed as oxides.

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2

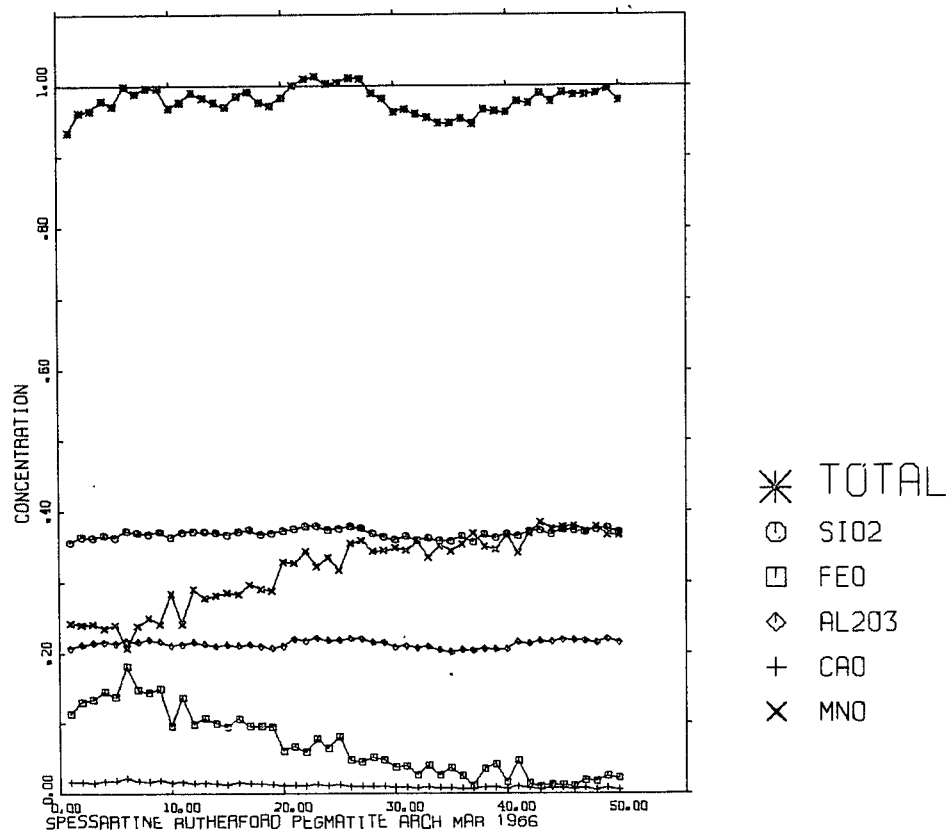


Figure 16. Output from Program EMX2. Plot of concentrations of oxides after correction. Similar plots can be obtained as the output of Program EMX. The analytical data in this problem are from Sinkankas and Reid (6).

```

PROGRAM EMX
COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,NO(10),WTPC(10),TAU(9),
1  NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2  XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3  NAME2(500),KEY(9),NP(9),KEY2,IOX,NS,IG,TOTAL(500),
4  YMAX,OC(9),SI(9)
COMMON/1775/CON(500,9),DINFO(200,7),NLD(200,3)
EQUIVALENCE(TIME,XINFO),(CON,DINFO),(CON(1401),NLD),(NAME2,TIME),
1  (TOTAL,CURRENT)
DEAD(T,OC) = OC/(1.0 - OC*T)
NPAGE = 0
JB = 2223642020202020B
4500

C
C READ AND AVERAGE DATA FOR ONE PROBLEM
C
1 CALL EMXINPUT (XMAX)
IF(ISTOP) 95,2
2 IF(.NOT.NS)55,3
3 CALL EMXHEAD
PRINT 200
200 FORMAT(25X,13H AVERAGED DATA/)
PRINT 201
201 FORMAT(15X,6H REL.,16X,14HSPECTROMETER 1,
1 11X,14HSPECTROMETER 2,11X,14HSPECTROMETER 3/15X,16H TIME CURR
2ENT,3X,3(17HCTS/SEC SIGMA,8X)/)

C
C FIND RELATIVE TIME, PRINT AVERAGED DATA AND STANDARD DEVIATIONS.
C
DO 5 M = 2,MNUM
M1 = NUM(M-1)
M2 = NUM(M) - 1
T = 0.0
DO 4 J = M1,M2
T = T + TIME(I)
TIME(I) = T - .5*TIME(I)
PRINT 205, I, NAME(I), TIME(I), CURRENT(I), (COUNTS(I,J), ERR(I,J
1 ), KD(I,J), NL(I,J), J=1,3)
205 FORMAT(15,2X,A8,F6.0,F10.4,3(F10.1,F10.1,I3,I2))
IF(XMODF(I,50))4,21
21 CALL EMXHEAD
PRINT 200
PRINT 201
4 CONTINUE
5 PRINT 310
310 FORMAT ( )
IF(.NOT.NR)56,53
53 IA = 0
55 CALL EMXHEAD
IFIRST = IA + 1
PRINT 203
PRINT 201
203 FORMAT(14H0DEADTIME DATA)
DO 54 IA = IFIRST,NR
PRINT 204, DINFO(IA),DINFO(IA,2),DINFO(IA,5),NLD(IA),DINFO(IA,3),
1 DINFO(IA,6),NLD(IA,2),DINFO(IA,4),DINFO(IA,7),NLD(IA,3)
204 FORMAT(21X,F10.4,3(2F10.1,I5))
IF(.NOT.XMODF(IA,50))55,54
54 CONTINUE

C
C COMPUTE DEADTIME CORRECTION COEFFICIENTS WHERE NECESSARY AND CORRECT FOR

```

## C DEADTIME

C

```

56 LAST = NUM(MNUM) - 1
   DO 7 I = 1,NEL
     ENCODE (5,320,NP(L))NO(L)
320 FORMAT(2X,I3)
     KEY(L) = 0
     IF(TAU(L))7,6
   6 CALL DEADTIME(L, XMAX)
   7 CONTINUE
     IF(.NOT.NS)1,17
17  DO 13 NN = 1,NEL
     JLAST = 3
     MM = NN
     IF(TAU(NN).LT.0,0)13,8
   8 IF(TAU(NN).LT.1,0)10,9
   9 MM = TAU(NN)
10  TT = TAU(MM)
     DO 15 JX = 1,JLAST
     DO 15 JX = 1,JLAST
     IF(NL(JX,JX).NE.NN)15,11
11  JLAST = JX
     COUNTS(JX,JX) = DEAD(TT,COUNTS(JX,JX))
15  CONTINUE
13  CONTINUE
     CALL FMXHEAD
     PRINT 275
275 FORMAT(25X,34HDATA AFTER CORRECTION FOR DEADTIME/)
     PRINT 201
     PRINT 276, (I3, (COUNTS(I3,J3),ERR(I3,J3),J3=1,3),I3=1, LAST)
276 FORMAT (15,26X,3(2F10.1,5X))

```

C

## C FIND TWO SUCCESSIVE STANDARDS AND INTERPOLATE BETWEEN TO CORRECT FOR DRIFT

C

```

DO 35 MX = 2,MNUM
M1X = NUM(MX-1)
M2X = NUM(MX) - 1
DO 35 JJ = 1,3
DO 16 I1 = M1X,M2X
IF(KD(I1,JJ).EQ.2,AND,NL(I1,JJ))18,16
16 CONTINUE
GO TO 35
18 I2 = I1 + 1
NL1 = NL(I1,JJ)
20 DO 22 I4 = I2,M2X
IF(KD(I4,JJ).EQ.2,AND,NL(I4,JJ).EQ.NL1)24,22
22 CONTINUE
GO TO 35
24 I2 = I4
CALL DRIFT (I1,I2,JJ,IFLAG)
K1 = I2 + 1
IF(KD(K1,JJ).NE.2)28,27
27 I1 = K1
GO TO 18
28 IF(IFLAG)30,32
30 I2 = K1 + 1
GO TO 20
32 I1 = I2
GO TO 18
35 CONTINUE

```

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```

      CALL EMXHEAD
      PRINT 277
277  FORMAT(25X,31HDATA AFTER CORRECTION FOR DRIFT?)
      PRINT 201
      PRINT 276, (15,(COUNTS(15,J5),ERR(15,J5),J5=1,3),15=1, LAST)
C
C SUBTRACT BACKGROUND FROM SAMPLES AND STANDARDS
C
      CALL BKGD(1)
      CALL BKGD(3)
37  CALL FMXHEAD
      PRINT 210
210  FORMAT(25X,60HCONCENTRATIONS CORRECTED FOR DEADTIME, DRIFT, AND BA
1CKGROUND//
      21X,36HSAMPLE CURRENT CTS/SEC TRATION CONC
1EN- RELATIVE76X,51HE
2ERROR/)
      DO 39 JP= 1,3
      DO 38 IP= 1, LAST
38  ERR(IP,JP) = ERR(IP,JP)/COUNTS(IP,JP)
      DO 39 IQ = 1,500
39  CON(IQ,JP) = 0.0
      DO 50 MY= 2,MNUM
      M1Y= NUM(MY-1)
      M2Y = NUM(MY) - 1
      DO 50 JY= 1,3
      DO 40 NNN= 1,NEL
      DO 400 IY= M1Y,M2Y
      IF(KD(IY,JY).EQ.2,AND.NL(IY,JY).EQ.NNN)42,400
400  CONTINUE
40  CONTINUE
      GO TO 50
42  STD = 1.0/COUNTS(IY,JY)
      SE = ERR(IY,JY)**2
      PRINT 310
      PRINT 213, IY,NNN,JB,CURRENT(IY),COUNTS(IY,JY),WTPC(NNN),ERR(IY,JY)
1  )
213  FORMAT (15,I2,2X,A8,F10.4,F10.1,F10.5,F10.3)
      DO 45 IZ = M1Y,M2Y
      IF(KD(IZ,JY).OR.NL(IZ,JY).NE.NNN)45,43
43  KN = KEY(NNN) = KEY(NNN) + 1
      IF(KN.LE.500)44,430
430  PRINT 240,NNN
240  FORMAT(//55H DIMENSION EXCEEDED----FURTHER DATA OMITTED FOR ELEMEN
1T,I3//)
      GO TO 40
44  CON(KN,NNN) = COUNTS(IZ,JY)*STD*WTPC(NNN)
      NAME2(KN) = NAME(IZ)
      E = SORTF(ERR(IZ,JY)**2 + SE)
      PRINT 213, IZ,NNN,NAME(IZ),CURRENT(IZ),COUNTS(IZ,JY),CON(KN,NNN),E
45  CONTINUE
      GO TO 40
50  PRINT 310
      KEY1 = KEY2 = KEY(1)
      DO 58 JZ= 2,NEL
      IF(KEY(JZ).EQ.KEY2)58,57
57  PRINT 250, JZ
250  FORMAT(///77H NUMBER OF SAMPLE DATA POINTS OF ELEMENT 1 DOES NOT
1EQUAL NUMBER FOR ELEMENT ,I1)
      KEY2 = XMAXOF(KEY2,KEY(JZ))
58  CONTINUE

```

```

DO 62 I = 1,KEY2
TOTAL(I) = 0.0
DO 60 J = 1,NEL
60 TOTAL(I) = TOTAL(I) + CON(I,J)
62 CONTINUE
CALL PLOT (NP)
DO 72 I = 1,KEY2
DO 71 J = 1,NEL
IF(CON(I,J).LT.0.0)69,71
69 CON(I,J) = 0.0
71 CONTINUE
72 WRITE (3,214) NAME2(I),(CON(I,J),J=1,NEL)
214 FORMAT(A8,9(3F8.0))
END FILE 3
IF(IOX)91,71
91 DO 92 IC = 1,KEY2
TOTAL(IC) = 0.0
DO 92 JC = 1,NEL
CON(IC,JC) = CON(IC,JC)*(1.0 + 0.(JC) + SI(JC))
92 TOTAL(IC) = TOTAL(IC) + CON(IC,JC)
CALL PLOT (NOM)
GO TO 1
95 END FILE 3
END
SUBROUTINE EMXINPUT (XMAX)
COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,N0(10),WTPC(10),TAU(9),
1 NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2 XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3 NAME2(500),KEY(9),NP(9),KEY2,IOX,NS,IG,TOTAL(500),
4 YMAX,0(9),SI(9)
COMMON/1775/DINFO(200,7),NLD(200,3),DUMMY(1995),X(101,5)
EQUIVALENCE (TIME,XINFO), (NAME2,TIME),(TOTAL,CURRENT)
C
C THIS SUBROUTINE READS DATA FOR ONE PROBLEM AND CALLS S.R. EMXSUM TO AVERAGE
C
ICHECK = 111111111112020B
1 READ 100, NPROB, ID, NEL, NDT, NS, MBKGD, SLIMIT, IG, XMAX,YMAX
100 FORMAT (I6,6A8,4I2,F3.0,I2,2F3.0)
IF(NPROB)5,3
3 ISTOP = 1
RETURN
5 CALL EMXHEAD
ISTOP = IOX = 0
PRINT 200, NEL, NDT, NS, MBKGD, SLIMIT
200 FORMAT ('18H NO. OF ELEMENTS =,I2/I3,26H DEADTIME READINGS PER SET/'
1 '13,24H SAMPLE READINGS PER SET/28H BACKGROUND READING METHOD =,
212/39H SIGMA FOR STANDARD PEAK MAY NOT EXCEED, F5.1,11H * SQRTF(N)
3 '///10X,50HATOMIC PER CENT W TAU OXYGEN SILICON/
4 '60H ELEMENT NUMBER OF STANDARD FACTOR FACTOR
5 '/')
READ 102,(N0(I),WTPC(I),TAU(I),0(I),SI(I),NOM(I),I=1,NEL)
102 FORMAT(1X,I3,F6.0, E15.5,2F10.0,5X,A5)
PRINT 202, (1,N0(I),WTPC(I),TAU(I),0(I),SI(I),NOM(I),I=1,NEL)
202 FORMAT (15,I9,5X,2PF10.6,0PE11.2,2F10.5,5X,A5)
DO 907 I = 1,NEL
IF(0(I))908,907
907 CONTINUE
GO TO 1111
908 IOX = 1
DO 909 I = 1,NEL

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      IF(SI(1))1000,909
909  CONTINUE
      GO TO 1111
1000 IOX = -IOX
1111 CONTINUE
      CALL EMXHEAD
      PRINT 204
204  FORMAT(25X,11H INPUT DATA/5X,68H NAME TIME CURRENT
1  SPEC 1 SPEC 2 SPEC 3 CODE/)
      N = NR = 0
      IB = 12121212121220208
      M = NUM(1) * 1
      N = N + 1
      IF(N.GT.800)90,8
      READ (2,104) (X(I,J),J=1,5),KODE,NAME(N)
104  FORMAT (F6.2,F6.3,3F6.0,A6,A8)
      IF(KODE.EQ.ICHECK)96,10
10  IF(KODE.NE.IB)12,11
11  M = M + 1
      PRINT 310
310  FORMAT( )
      NUM(M) = N
      IF(M.EQ.25)96,8
12  PRINT 206, N, NAME(N), (X(I,J),J=1,5), KODE
206  FORMAT (15,2X,A8,F10.2,F10.3,3F10.0,2X,A8)
      DECODE (8,500,KODE) (KD(N,J), NL(N,J),J=1,3)
300  FORMAT (61I, 2X)
      IF(KD(N).GE.2)25,13
13  IF(NS.NE.1)17,14
14  XINFO(N) = X
      X = 1.0/X
      DO 15 J = 1,3
      K = J + 2
15  ERR(N,J) = SQRTF(X(1,K))*X
      DO 16 J = 2,5
16  XINFO(N,J) = X(1,J)*X
      GO TO 7
17  DO 20 I = 2,NS
      READ (2,104) (X(I,J),J=1,5),JKODE,JUNK
      PRINT 206, N, JUNK, (X(I,J),J=1,5),JKODE
      IF(JKODE.EQ.KODE)20,19
19  PRINT 208
208  FORMAT(/75H ERROR IN GROUPING DATA--FURTHER PROCESSING DELETED)
65  IF(JKODE.EQ.ICHECK)1,95
20  CONTINUE
      CALL FMXSUM (N, NS)
      GO TO 7
25  IF(KD(N).NE.4)28,26
26  NR = NR + 1
      IF(NR.GT.200)90,27
27  DO 50 I = 2,NDT
      READ (2,104) (X(I,J),J=1,5),JKODE,JUNK
      PRINT 206, NR,JUNK, (X(I,J),J=1,5),JKODE
      IF(JKODE.NE.KODE)19,50
50  CONTINUE
      CALL EMXSUM (N,NDT)
      DO 55 J = 1,7
      K = J + 1
55  DINFO(NR,J) = XINFO(N,K)
      DO 60 J = 1,3

```

```

60 NLD(NR,J) = NL(N,J)
GO TO 8
28 DO 61 J = 1,3
  IF(KD(N,J).EQ.2,62,61)
61 CONTINUE
GO TO 13
62 I = 1
29 I = I + 1
  IF(I.GT.101,90,30)
30 READ (2,104) (X(I,J),J=1,5),JKODE,JUNK
  IF(JKODE.NE.KODE,31,75)
75 PRINT 206, N, JUNK, (X(I,J),J=1,5),JKODE
GO TO 29
31 NX = I - 1
  CALL EMXSUM (N, NX)
  IF(.NOT.ISTOP)32,64
64 ISTOP = 0
GO TO 65
32 KODE = JKODE
N = N + 1
  IF(N.GT.800)90,42
42 NAME(N) = JUNK
DO 43 J = 1,5
43 X(1,J) = X(I,J)
GO TO 9
90 PRINT 250
250 FORMAT (///52H ERROR--DIMENSION EXCEEDED--DATA CANNOT BE PROCESSED
1/)
95 READ 150, JKODE
150 FORMAT(30X,A6)
  IF(JKODE.EQ.ICHECK)1,95
96 MNUM = M + 1
  NUM(MNUM) = N
END
SUBROUTINE EMXHEAD
COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,N0(10),WTPC(10),DCA(9),
1  NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2  XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3  NAME2(500), KEY(9), NP(9), KEY2, IOX, NS, IG, TOTAL(500),
4  YMAX, O(9), SI(9)
EQUIVALENCE (TIME,XINFO), (NAME2,TIME),(TOTAL,CURRENT)

C
C PAGE HEADING ROUTINE
C
  NPAGE = NPAGE + 1
  PRINT 200, NPROB, ID, NPAGE
200 FORMAT(12H1PROBLEM NO. 16,5X,6A8,30X,4HPAGE 13/)
END
SUBROUTINE EMXSUM (NY,NX)
COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,N0(10),WTPC(10),DCA(9),
1  NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2  XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3  NAME2(500), KEY(9), NP(9), KEY2, IOX, NS, IG, TOTAL(500),
4  YMAX, O(9), SI(9)
COMMON/1775/DUMMY(3990),SUM(5),X(101,5)
EQUIVALENCE (TIME,XINFO), (NAME2,TIME),(TOTAL,CURRENT)
4500

C
C THIS SUBROUTINE AVERAGES DATA SETS, COMPUTES STANDARD DEVIATIONS,
C AND CONVERTS TO COUNTS PER SECOND.
C

```

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```

      N = NY
      XN = FLOATF(NX)
      DO 5 JJ= 1,5
      SUM(JJ)= 0.0
      DO 5 I = 1,NX
5      SUM(JJ) = SUM(JJ) + X(I,JJ)
      TIME(N) = SUM
      X = 1.0/SUM
      CURRENT(N) = SUM(2)*X
      DO 20 J = 1,3
      K = J + 2
      IF(NL(N,J))9,7
7      COUNTS(N,J) = ERR(N,J) = 0.0
      GO TO 20
9      TEST = SQRTF(SUM(K))*X
      S = SUM(K)/XN
      DEV = 0.0
      DO 10 I = 1,NX
10     DEV = DEV + (X(I,K) - S)**2
      DEV = SQRTF(DEV)*X
      IF(KD(N,J).NE.2)15,11
11     IF(DEV.LE.SLIMIT*TEST)15,12
12     DEV = DEV/TEST
      PRINT 200,DEV
200  FORMAT(///32H SCATTER IN STANDARD READING IS ,F4.1,33H * SQRTF(N)
1--FURTHER DATA OMITTED////)
      ISTOP = 1
      RETURN
15     ERR(N,J) = MAX1F(DEV,TEST)
      XINFO(N,K) = SUM(K)*X
20     CONTINUE
      END
      SUBROUTINE DEADTIME(N, XMAX)
      COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,N0(10),WTPC(10),TAU(9).
1      NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2      XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3      NAME2(500),KEY(9),NP(9),KEY2,IOX,NS,IG,TOTAL(500),
4      YMAX, O(9), SI(9)
      COMMON/1775/DINFO(200,7),NLD(200,3),DELY(200),Y(200),B(2),SB(2),
1      DUMMY(2096)
      EQUIVALENCE (DCTS,DINFO(201)), (DE,DINFO(801))
      EQUIVALENCE (TIME,XINFO), (NAME2,TIME),(TOTAL,CURRENT)
      DIMENSION DCTS(200,3),DE(200,3)
      DO 5 J = 1,3
      DO 5 I1 = 1,NR
      IF(NLD(I1,J).EQ.N)6,5
5      CONTINUE
      PRINT 250, N
250  FORMAT(///29H NO DEADTIME DATA FOR ELEMENT,I2,38H---NO DEADTIME CO
1RRECTION WILL BE MADE)
      TAU(N) = -1.0
      RETURN
6      I2 = I1 + 1
      DO 8 I = I2,NR
      IF(NLD(I,J).EQ.N)8,10
8      CONTINUE
      I2 = NR
      ND = NR - I1 + 1
      GO TO 11
10     I2 = I - 1

```

```

ND = I - I1
11 DO 15 I = I1,I2
   DCTST(I,J) = DCTS(I,J)/DINFO(I)
15 DE(I,J) = (DINFO(I)/DE(I,J))**2
   CALL EMXHEAD
   CALL LSQ (ND,I,SIG,DINFO(I),DCTS(I1,J),DE(I1,J),Y(I1), DELY,R,SB)
   TAU(N) = -B(2)/B(1)*4
   PRINT 200, NO(N), J, TAU(N)
200 FORMAT(777713H FOR ELEMENT ,I2,16H ON SPECTROMETER,I2,
1 8H, TAU = ,E9.2,8H SECONDS)
   DX = XMAX*.10
   DY = .125*B
   DIV = 100.*XMAX
   CALL CCAXIS (0.,0.,14HCOUNTS/CURRENT,14,8.,90.,0.,DY,12.5)
   CALL CCAXIS(0.,8.,20HCURRENT (MICRO-AMPS),-20,10.,0.,0.,DX,-DIV)
   CALL CCAXIS (10.,0.,14.,-1.8.,90.,0.,DY,-12.5)
   CALL CCAXIS (0.,0.,20HCURRENT (MICRO-AMPS),-20,10.,0.,0.,DX,DIV)
   CALL CCSYMBOL (1.,10.,.21,10,0.,48)
   CALL P2LINE (DINFO(I1),DCTS(I1,J),ND,1,-1,3.,07,0.0,DX,0.0,DY)
   YNEW = (B + XMAX*B(2))/DY
   CALL CCPLLOT (10.,YNEW,3)
   CALL CCPLLOT (0.,8.,2)
   CALL CCPLLOT (0,0,-3)
   END
   SUBROUTINE LSQ (M,IW,SIGMA,X,F2,W,Y,DELY,B,SB)
C
C SHORT VERSION OF E2 UCSD LSQPOL--FOR FITTING WITH STRAIGHT LINE ONLY.
C ETN-63
C JANUARY, 1966
C
   DIMENSION S(2), X(200), F2(200), ST(2), SB(2), F(200), PM(200),
1 P(200), B(2), DELY(200), W(200), A(2,2), T(2), Y(200)
   LL = 0
   A = A(2,2) = 1.0
   FBAR = XBAR = FM = 0.0
   DO 10 I = 1,M
   IF(IW)1009,1010
1010 W2 = W(I) = 1.0
   GO TO 1011
1009 W2 = SORTF(W(I))
1011 FM = FM + W(I)
   F(I) = W2*F2(I)
   PM(I) = W2
   FBAR = FBAR + F(I)*PM(I)
10 XBAR = XBAR + X(I)*PM(I)**2
   XBAR = XBAR/FM
   T(1) = FBAR/FM
   A(2,1) = -XBAR
   PXF = PXP = 0.0
   DO 20 I = 1,M
   P(I) = (X(I) - XBAR)*PM(I)
   PXF = PXF + P(I)*F(I)
20 PXP = PXP + P(I)**2
   T(2) = PXF/PXP
   S(1) = PMXPM = FM
   B(1) = T(1)*A(1,1) + T(2)*A(2,1)
   B(2) = T(2)*A(2,2)
165 SIG2 = 0.0
   DO 180 I = 1,M
   Y(I) = B(1) + B(2)*X(I)

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175 DELY(I) = Y(I) + F2(I)
180 SIG2 = SIG2 + (DELY(I)**2)*W(I)
    SIG2 = SIG2/(M - 2)
    SIGMA = SQRTF(SIG2)
    S(2) = PXP
    DO 499 I = 1,2
499 ST(I) = SIGMA/SQRTF(S(I))
    DO 501 I = 1,2
    SB(I) = 0.0
    DO 500 J = 1,2
500 SB(I) = SB(I) + (A(J,I)*ST(J))**2
501 SB(I) = SQRTF(SB(I))
192 PRINT 1, (1,B(I),SB(I),I=1,2)
    1 FORMAT (36H0COEFFICIENTS OF Y=B1+B2X AND ERRORS//      2(3H B(I),
    1 2H)=E15.7,6H ERRB=E10.3))
185 PRINT 186, SIGMA
186 FORMAT (8H0SIGMA =E16.7)
670 PRINT 2, (1,X(I),F2(I),Y(I),DELY(I),W(I),I=1,M)
    2 FORMAT(47H0 I      X(I)      F(I)
137HY(I)      DELY(I)      W(I)//(16,5E16.7))
190 CONTINUE
END
SUBROUTINE DRIFT (I1,I2,J,IFLAG)
COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,NO(10),WTPC(10),DCA(9),
1  NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2  XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3  NAME2(500),KEY(9),NP(9),KEY2,IOX,NS,IG,TOTAL(500),
4  YMAX,D(9),SI(9)
EQUIVALENCE (TIME,XINFO), (NAME2,TIME), (TOTAL,CURRENT)
IF(ABS(COUNTS(I1,J) - COUNTS(I2,J)).LE.MAX1F(ERR(I1,J),ERR(I2,J))
1  )/90,2
2  T = TIME(I1)
CF = (COUNTS(I2,J)/COUNTS(I1,J) - 1.0)/(TIME(I2) - T)
5  K1 = I1 + 1
  K2 = I2 - 1
  IFLAG = 0
  DO 10 I = K1,K2
10 COUNTS(I,J) = COUNTS(I,J)/(1.0 + CF*(TIME(I)-T))
  RETURN
90 PRINT 200, I1,I2,J
200 FORMAT(//31H DRIFT BETWEEN STANDARDS LINES ,I3,5H AND ,I3,
1  14H, SPECTROMETER,I2,
1  51H IS WITHIN COUNTING ERROR--NO DRIFT CORRECTION MADE)
  IFLAG = 1
END
SUBROUTINE BKGD (KKD)
COMMON SLIMIT,NPROB,IO(6),NEL,MBKGD,NR,NO(10),WTPC(10),DCA(9),
1  NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2  XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3  NAME2(500),KEY(9),NP(9),KEY2,IOX,NS,IG,TOTAL(500),
4  YMAX,D(9),SI(9)
EQUIVALENCE (TIME,XINFO), (NAME2,TIME), (TOTAL,CURRENT)
C
C THIS SUBROUTINE LOCATES BACKGROUND READINGS AND SUBTRACTS THEM FROM
C THE APPROPRIATE PEAK.
C
  KODE = KKD
  MODE = KODE - 1
  DO 50 J = 1,3
  DO 50 M = 2,MNUM

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      M1 = NUM(M-1)
      M2 = NUM(M) - 1
      J1 = M1
3    DO 5 I1 = M1,M2
      IF(KD(I1,J).EQ.KODE.AND.NL(I1,J)8,5
5    CONTINUE
      GO TO 50
8    I2 = I1 + 1
      J2 = M2
      NL1 = NL(I1,J)
      DO 10 I = I2,M2
      IF(KD(I,J).EQ.KODE.AND.NL(I,J).EQ.NL1)12,10
10   CONTINUE
      B = COUNTS(I1,J)
      EBSQ = ERR(I1,J)**2
      GO TO 17
12   I2 = I
      J2 = I2 + 1
      DO 13 I = J2,M2
      IF(KD(I,J).EQ.KODE.AND.NL(I,J).EQ.NL1)15,13
13   CONTINUE
      J2 = M2
      GO TO 22
15   J2 = I - 1
22   B = (COUNTS(I1,J) + COUNTS(I2,J))* .5
      EBSQ = (ERR(I1,J)**2 + ERR(I2,J)**2)*.25
17   IF(.NOT.MBKGD)30,23
23   DO 25 I = J1,J2
      IF(KD(I,J).NE.MODE.OR.NL(I,J).NE.NL1)25,24
24   COUNTS(I,J) = COUNTS(I,J) - B
      ERR(I,J) = SQRTF(ERR(I,J)**2 + EBSQ)
25   CONTINUE
      J1 = J2 + 2
      GO TO 41
30   DO 35 I = J1,J2
      IF(KD(I,J).EQ.MODE.AND.NL(I,J).EQ.NL1)40,35
35   CONTINUE
      PRINT 205, I1, I2
205  FORMAT(/7738H NO SAMPLE DATA FOR BACKGROUND, LINES ,13,16)
      GO TO 41
40   COUNTS(I,J) = COUNTS(I,J) - B
      ERR(I,J) = SQRTF(ERR(I,J)**2 + EBSQ)
      J1 = I + 1
41   IF(J2.GE.M2)50,42
42   I1 = J2 + 1
      GO TO 8
50   CONTINUE
      END
      SUBROUTINE PPLOT (N)
      COMMON SLIMIT,NPROB,ID(6),NEL,MBKGD,NR,N0(10),WTPC(10),TAU(9),
1     NOM(9),TIME(800),CURRENT(800),COUNTS(800,3),ERR(800,3),
2     XINFO(800,8),KD(800,3),NL(800,3),ISTOP,NUM(26),MNUM,NAME(800),
3     NAME2(500),KEY(9),NP(9),KEY2,IOX,NS,IG,TOTAL(500),
4     YMAX, O(9), SI(9)
      COMMON/1775/CON(500,9),DINFO(200,7),NLD(200,3)
      DIMENSION IPREF(9), X(500), N(20)
      EQUIVALENCE(TIME,XINFO), (CON,DINFO), (CON(1401),NLD), (NAME2,TIME),
1     (TOTAL,CURRENT), (X,ERROR)
      DATA (IPREF = 4,3,5,0,1,2,6,7,9)
      CALL EMXHEAD

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      PRINT 220, (N(L),L=1,NEL)
220  FORMAT(25X,60HCNCONCENTRATIONS CORRECTED FOR DEADTIME, DRIFT, AND BA
      1CKGROUND//15X,5HTOTAL,10(5X,A5))
      DO 10 I = 1,KEY2
      PRINT 256, NAME2(I), TOTAL(I), (CON(I,JJ), JJ = 1,NEL)
256  FORMAT(2X,A8,11(2PF10.4))
      IF(XMODF(I,5))10,5
      5 IF(XMODF(I,45))8,7
      7 CALL EMXHEAD
      PRINT 220, (N(K),K=1,NEL)
      GO TO 10
      8 PRINT 400
400  FORMAT ( )
      10 CONTINUE
      14 IF(IG)15,90
      90 RETURN
      15 IF(N.NE.NP)30,16
      16 IF(IOX)90,30
      30 YLEN = 8.6614
      YYMAX = YMAX*1.1
      XLEN = FLOATF((KEY2+7)/78)
      PX1 = XLEN * 1.0
      PX2 = XLEN * 1.5
      CALL CCPL0T(XLEN+3.0,0.0)
      33 DO 35 IA = 1,KEY2
      35 X(IA) = IA
      PY1 = .78924
      PY2 = .7874
      DX = 8.0
      DY = YYMAX/YLEN
      DO 40 J = 1,NEL
      CALL P2LINE (X, CON(1,J), KEY(J), 1,1,IPREF(J),.07,0.0,DX,0.0,DY)
      CALL CCSYMBOL (PX1,PY1,.21,IPREF(J),0.0,-1)
      CALL CCSYMBOL (PX2,PY2,.21,N(J),0.0,5)
      PY1 = PY1 + .5
      PY2 = PY2 + .5
      40 CONTINUE
      CALL P2LINE (X, TOTAL, KEY2, 1,1,11,.07,0.0,DX,0.0,DY)
      CALL CCSYMBOL (PX1,PY1,.35,11,0.0,-1)
      CALL CCSYMBOL (PX2,PY2,.35,5HTOTAL,0.0,5)
      CALL CCAXIS (0.,0.,60HCNCONCENTRATIONS CORRECTED FOR DEADTIME, DRIFT
      1, AND BACKGROUND,60,YLEN,90,0.0,0.0,DY,12.7)
      CALL CCAXIS (XLEN,0.,ID,8,YLEN,90,0.,DY,-12.7)
      CALL CCAXIS (0.,7.874,ID,-48,XLEN,0.0,0.0,8.0,-8.0)
      CALL CCAXIS (0.,0.,ID,-48,XLEN,0.0,0.0,8.0,8.0)
      CALL CCAXIS (0.,YLEN,ID,-48,XLEN,0.0,0.0,8.0,-8.0)
      DO 50 IC = 1,KEY2
      IF(NAME2(IC).EQ.1H )50,45
      45 PX = X(IC)*.125
      CALL CCSYMBOL (PX,YLEN,.14,NAME2(IC),45,.8)
      50 CONTINUE
      CALL CCPL0T(0.0,-3)
      END
      SUBROUTINE P2LINE(X,Y,N,K,J,L,H,XMIN,DX,YMIN,DY)
CLINE  VERSION 5 COPYRIGHT 1964 CALIFORNIA COMPUTER PRODUCTS      LINE0010
      DIMENSION X(1), Y(1)
      C
      C
      C
      C
      X IS THE NAME OF THE ARRAY OF ORDINATE VALUES.(SEE NOTE) LINE0040
      Y IS THE NAME OF THE ARRAY OF ABSCISSE VALUES.(SEE NOTE) LINE0050
      N IS THE NUMBER OF POINTS IN THE ARRAY      LINE0060

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C      K IS THE REPEAT CYCLE OF A MIXED ARRAY (NORMALLY = 1). LINE0070
C      J IS THE ALTERNATE NUMBER OF DATA POINT TO PLOT A SYMBOL. LINE0080
C      J WILL = 0 FOR LINE PLOT, NEGATIVE FOR POINT PLOT. LINE0090
C      J = 1 FOR POINT FOR EVERY DATA POINT, 2 FOR EVERY OTHER. LINE0100
C      L IS AN INTEGER DESCRIBING SYMBOL TO BE USED, SEE SYMBOL LINE0110
C      ROUTINE FOR LIST LINE0120
C
      NP = N * K * 1 LINE0160
      NQ = NP * K LINE0170
      NO = NP - K LINE0180
      I3 = 3 LINE0190
      CALL CWHERE(XN,YN) LINE0240
      I2 = -1 LINE0250
      XN = XN * DX + XMIN LINE0260
      YN = YN * DY + YMIN LINE0270
      DX1 = ABSF(X(1),XN) LINE0280
      DY1 = ABSF(Y(1),YN) LINE0290
      DX2 = ABSF(X(NO)-XN) LINE0300
      DY2 = ABSF(Y(NO)-YN) LINE0310
      DX1 = MAX1F(DX1,DY1) LINE0320
      DX2 = MAX1F(DX2,DY2) LINE0330
      KK = K LINE0340
      NA=NT=J $ IF(N#) 100,101,102 LINE0350
100  NT=-NT
102  NA = (N-1)/NT LINE0370
101  NA = NA * NT + NT + 1 - N LINE0380
      IF (DX1-DX2) 10,10,20 LINE0390
      10 NO = 1 LINE0400
      KK = -KK LINE0410
      NA = NT LINE0420
      20 NV = 2 LINE0430
      NW = -2 LINE0440
      KL = 2 LINE0450
      IF (J) 30,40,50 LINE0460
      30 NV = 3 LINE0470
      NW = -1 LINE0480
      KL = 1 LINE0490
      GO TO 50 LINE0500
      40 NA = NP LINE0510
      50 DO 90 I = 1,N LINE0520
          IF (NA-NT) 65,60,70 LINE0530
      60 CALL CCSYMBOL((X(NO)-XMIN)/DX,(Y(NO)-YMIN)/DY,H,L,0.0,I2) LINE0540
          NA = 1 LINE0550
          GO TO 80 LINE0560
      65 GO TO (75,70),KL LINE0570
      70 CALL CCPLLOT((X(NO)-XMIN)/DX,(Y(NO)-YMIN)/DY,I3) LINE0580
      75 NA = NA + 1 LINE0590
      80 I3 = NV LINE0600
      I2 = NW LINE0610
      90 NO = NO + KK LINE0620
      RETURN LINE0630
      END LINE0640

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PROGRAM EMX2
COMMON NPROB, ID(6), NEL, EO, NZ(20), SCON(20), SCF(20), MUBAR,
1  O(20), IOX, NELP1, NF(20), NZF(20,4), Z(20), R(20,4), EC(20),
2  SIGMA(20), WK(20), MU(20,20), U(20,4), SI(20), NVAR, NELP2,
3  OCON(20), CON(20), DELCON(20), NOM(20), NS, NP(20), IMIN,
4  IMAX, IG, YMAX, DMIN -----
COMMON/PP/NAME2(500), Y(500,20), TOT(500)
NTOTAL = 5H TOT
CALL CONSTANT
1 NPAGE = IOX = 0
CALL SETUP
IF(SCF)9,4
4 DO 5 I = 1,NEL
5 CON(I) = SCON(I)
CALL OXYGEN
PRINT 200
200 FORMAT(11X,53H-----STANDARD FOR ELEMENT Z----- OXYGEN SILICO
IN/94H NL Z CONCENTRATION F(CHI)*(1+FLUOR) FACTOR FAC
2TOR F(CHI) I(FL)/I/)
DO 6 I = 1,NEL
FCHI = ABSORB(I)
FL = FLUOR(I)
SCF(I) = FCHI*(1.0+FL)
PUNCH 302, I, NZ(I), SCON(I), SCF(I), O(I), SI(I),NOM(I)
302 FORMAT(2I5,4F10.6,5X,A5)
6 PRINT 202, I, NZ(I), SCON(I), SCF(I), O(I), SI(I), FCHI, FL
202 FORMAT(I3,I5,F13.6,F20.6,F13.6,F10.6, 10X, 2F10.6)
GO TO 1
9 NS = 0
8 READ (3,100) NAME,(OCON(I), I = 1,NEL)
100 FORMAT (A8,9E8.0/8X,9E8.0)
IF(EOF,3)75,7
7 DO 11 I = 1,NVAR
CON(I) = OCON(I)
11 OCON(I) = OCON(I)*SCF(I)
CALL OXYGEN
NIT = 0
CALL PAGE
PRINT 204, NAME
204 FORMAT(10X, A8//50H NIT Z CON DELCON F(CHI) I/I(
1FL)/)
DO 12 I = 1,NEL
12 PRINT 206, NIT, NZ(I), CON(I)
206 FORMAT(2I5,4F10.6)
16 TOTAL = 0.0
DO 17 I = 1,NELP2
17 TOTAL = TOTAL + CON(I)
IF(IOX)18,20
18 PRINT 206, NIT, NZ(NELP1), CON(NELP1)
IF(IOX.GT.0)20,19
19 PRINT 206, NIT, NZ(NELP2), CON(NELP2)
20 PRINT 208, NIT,NTOTAL, TOTAL
208 FORMAT (I5,A5,F10.6)
IF(NIT.LT.IMIN)26,27
27 IF(NIT.EQ.IMAX)85,29
29 DO 31 I = 1,NVAR
IF(CON(I).GT..01.AND.DELCON(I).GT.DMIN)26,31
31 CONTINUE
GO TO 85
26 PRINT 400
400 FORMAT()
NIT = NIT + 1

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DO 25 I = 1,NVAR
FCHI = ABSORB(I)
FL = FLUOR(I)
CON2 = OCON(I)/(FCHI*(1.0 + FL))
DELCON(I) = CON2 - CON(I)
IF (O(I))21,24
21 CON(NELP1) = CON(NELP1) + DELCON(I)*O(I)
IF(SI(I))22,24
22 CON(NELP2) = CON(NELP2) + DELCON(I)*SI(I)
24 CON(I) = CON2
25 PRINT 206, NIT, NZ(I), CON2, DELCON(I), FCHI, FL
GO TO 16
85 NS = NS + 1
IF(NS.LE.500)86,60
60 PRINT 260
!60 FORMAT(///57H.DIMENSION EXCEEDED--REMAINING POINTS CANNOT BE CORRE
1CTED)
62 READ (3,110)NAME
10 FORMAT(A8)
IF(EOF,3)75,62
86 NAME2(NS) = NAME
TOT(NS) = TOTAL
DO 40 J = 1,NELP2
40 Y(NS,J) = CON(J)
GO TO 8
75 CALL PRNTPLOT (NP, NELP2)
IF(IOX)50,1
50 DO 76 J = 1,NEL
XX = 1.0 + O(J) + SI(J)
DO 76 I = 1,NS
76 Y(I,J) = Y(I,J)*XX
CALL PRNTPLOT (NOM,NEL)
GO TO 1
END

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SUBROUTINE CONSTANT
TYPE REAL LAMBDA, MU
COMMON/DATA/AL(92), LAMBDA(92), EDGE(92,7), C(92,8), EXP(92), WAVL,
1 SINTHETA, AWK, BWK, CWK, CSIG, XSIG DATA
DATA (A = 1.008,4.003,6.939,9.012,10.810,12.011,14.007,15.999, A
1 19.000,20.183,22.990,24.310,26.980,28.090,30.974,32.064,35.453, A
2 39.948,39.102,40.080,44.960,47.900,50.940,52.54,94,55.85,58.93 A
3 58.71,63.54,65.37,69.72,72.59,74.92,78.96,79.909,83.8,85.47, A
4 87.62,88.905,91.22,92.91,95.94,98.101,1.102,905,106.4,107.87, A
5 112.4,114.82,118.69,121.75,127.6,126.9,131.3,132.905,137.34, A
6 138.91,140.12,140.91,144.24,147.150,35,152.157,25,158.92, A
7 162.5,164.93,167.26,168.93,173.04,174.97,178.49,180.95,183.85, A
8 186.2,190.2,192.2,195.09,196.97,200.59,204.37,207.19,208.98, A
DATA (A(84) = 210.,210.,222.,223.,226.,227.,232.04,231.,238.93) A84
DATA(LAMBDA(5) = 67.6,44.7,31.6,23.62,18.32,14.61,11.91,9.89,8.34, LAMBDA
1 7.126,6.157,5.373,4.728,4.192,3.742,3.359,3.031,2.749,2.504, LAMBDA
2 2.29,2.102,1.937,1.79,1.658,1.541,1.436,1.341,1.255,1.176,1.105 LAMBDA
3 1.04,7.817) LAMBDA
DATA (LAMBDA(37) = 7.318,6.863,6.449,6.07,5.724,5.407,5.115,4.846, LMDA37
1 4.597,4.368,4.154,3.956,3.772,3.63,3.439,3.289,3.149,3.017,2.892 LMDA37
2 2.776,2.666,2.561,2.463,2.37,2.282,2.2,2.121,2.047,1.977,1.909 LMDA37
3 1.845,1.784,1.727,1.672,1.62,1.57,1.522,1.476,1.433,1.391, LMDA37
4 1.351,1.313,1.276,1.313,1.207,1.175,4.909,6(0),3.941,3.827, LMDA37
5 3.716) LMDA37
DATA (EXP(3) = 2.88,2.86,2.85,2.84,2.83,2.82,2.81,2.80,2.79,2.79, EXP

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1 2.78,2.77,2.77,2.76,2.76,2.75,2.75,2.74,2.74,3(2.73),2(2.72), EXP
2 3(2.71),3(2.71),3(2.69),6(2.73),5(2.72),4(2.71),3(2.7),3(2.69), EXP
3 3(2.68),3(2.67),2(2.66),3(2.65),2(2.64),2(2.63),2(2.62),2(2.61) EXP
4 2.6,2.6,2.59,2.59,2.58,2.58,2.57,10(2.61) EXP
DATA (EDGE) = 9(15.), 14.3,11.569,9.512,7.951,6.745,5.787,5.018, EDGE
1 4.379,3.871,3.437,3.07,2.757,2.497,2.269,2.07,1.896,1.743, EDGE
2 1.608,1.488,1.38,1.283,1.196,1.117,1.045,98,92,6,46,5,998, EDGE
3 5.583,5.232,4.867,4.581,4.298,4.06,3.83,3.626,3.428,3.254,3.085,EDGE
4 2.926,2.777,2.639,2.511,2.389,2.274,2.167,2.068,1.973,1.889, EDGE
5 1.811,1.735,1.665,1.599,1.536,1.477,1.421,1.365,1.317,1.268, EDGE
6 1.222,1.182,1.14,1.1,1.061,1.025,99,956,923,893,863,835, EDGE
7 .808,.782,3.099,6(0.),2.401,2.313,2.235) EDGE
DATA (EDGE(104) = 16(15.), 14.24, 11.27, 10.3, EDGE104
1 9.54,8.73,8.107,7.506,6.97,7.21,6.643, EDG5104
1 6.172,5.755,5.378,5.026,4.718,4.436,4.18,3.942,3.724,3.514,3.32 EDGE104
2 6.3,147,2.982,2.83,2.687,2.553,2.429,2.314,2.204,2.103,2.011, EDGF104
3 1.924,1.843,1.767,1.703,1.626,1.561,1.501,1.438,1.39,1.338, EDGE104
4 1.288,1.243,1.199,1.155,1.114,1.075,1.037,1.001,967,934,903, EDGE104
5 .872,.843,.815,3.355,6(0.),2.577,2.479,2.394) EDGE104
DATA (EDGE(214) = 11.87)
DATA (EDGE(215) = 10.9,9.94,9.124,8.416,7.8,7.43,6.89,6.387,5.961, EDGE215
1 5.538,5.223,4.913,4.632,4.369,4.13,3.908,3.698,3.504,3.324, EDGE215
2 3.156,3,2.855,2.719,2.592,2.474,2.363,2.258,2.164,2.077,1.995, EDGE215
3 1.918,1.845,1.775,1.71,1.649,1.579,1.535,1.482,1.433,1.386, EDCE215
4 1.341,1.297,1.255,1.216,1.177,1.14,1.106,1.072,1.04,1.008,979, EDGE215
5 .953,9.02,6(0.),3.08,2.98,2.882) EDGE215
DATA (EDGE(308) = 10.2,9.39,8.67,8.20(10.),9.557,9.042,8.614, EDGE308
1 8.188,7.831,7.513,7.178,6.856,6.566,6.292,6.088,5.82,5.581, EDGE308
2 5.366,5.161,4.972,4.753,4.569,4.405,4.231,4.064,3.915,3.774, EDGE308
3 3.62,3.482,3.349,3.218,4.808,6(0.),3.745,3.614,3.496) EDGE308
DATA (EDGE(401) = 3(10.), (EDGE(424) = 10.8,10.3,9.6,9.258, EDGE401
1 8.773,8.376,8.023,7.642,7.322,7.011,6.715,6.453,6.179,5.931, EDGE401
2 5.686,5.475,5.211,5.015,4.823,4.625,4.443,4.273,4.114,3.939, EDGE401
3 3.779,3.632,3.484,10.6(0.),3(10.11) EDGE401
DATA (EDGE(611) = 6(10.),9.957,9.528,9.115,8.773,8.433,8.086,7.777 EDGE611
1 7.427,7.128,6.871,6.594,6.357,6.094,5.88,5.629,5.413,5.2, EDGE611
2 4.994, (EDGE(518) = 10.4,9.957,9.499,9.115,8.705,8.331,7.997, EDGE611
3 7.685,7.383,7.128,6.834,6.559,6.331,6.112,5.861,5.637,5.451, EDGE611
4 5.253,5.06,4.873,4.71,4.522,4.349,4.201,4.042) EDGE611
DATA (C(3) = .135,.35,.74,1.35,2.21,3.8,4.9,6.77,9.05,11.75,14.87, C3
1 18.5,22.5,27,31.7,36.9,42.5,48,4.55,1.62,1.69,8.78,8.86,7, C3
2 95.8,105.5,115.9,126.8,138,149.8,162.2,175.4,189,4.205,31.25, C3
3 33.9,36.5,39.3,42.3,45.5,48.5,52.1,55.6,59.3,63.1,67.3,71,75.5, C3
4 79.6,84,2.88,5.94,9.98,3.103,4.109,11.4,4.120,12.5,5.132, C3
5 138.5,143.5,150,157,163.5,170.5,176.5,184,192.5,199,206, C3
6 214,222,231,239,247,256,263,272,281,289,298,79.94, C3
7 6(0.),109.4,114,5,120.7) C3
DATA (C(104) = .89,1.18,1.54,1.96,2.43,2.98,3.62,4.31,5.1,5.99, C104
1 7.8,02,9.18,10.45,11.75,13.25,14.8,16.45,18.25,20.2,22.15, C104
2 24.25,26.4,28.8,26.7,28.8,31.2,33.5,36.15,38.9,41.45,44.5,47.5, C104
3 50.7,53.95,57.5,60.7,64.5,68,71.95,75.65,80.35,84,88.4,93.15, C104
4 97.8,102.5,107.3,112.8,118.5,122.5,128,134,140,146,151,157 C104
5 .165,170,176,183,190,197,204,211,219,225,232,240, C104
6 247,255,68.9,610,1,94,3,98,7,104,1, (C(214)=15,6) C104
DATA (C(215) = 17.25,18.95,20.75,22.55,24.6,19.15,20.8,22.4,24.1, C215
1 25.95,27.9,29.75,31.95,34.1,36.4,38.7,41.3,43.6,46.3,48.8,51.7, C215
2 54.3,57,60.3,63,66,69,70,2.73,6.77,81,85,88,92,96,3, C215
3 100.3,104.5,108.5,113,118,122,126,131,136,142,147,152, C215
4 157,161,167,172,177,183,57,1.6(0.),78,1,81,8,86,2) C215
DATA (C(308)=13.6,14.9,16.2,17.7,5.6,6.1,6.6,6.2,7.18,7.78,8.39,9.05, C308
1 9.74,10.47,11.24,12.03,12.87,13.76,14.68,15.65,16.66,17.72, C308
2 18.82,19.97,21.16,22.41,23.7,25.05,26.47,27.93,29.44,31.01, C308

```

```

3 32.63,34.31,36.06,37.86,39.76,41.69,43.69,45.79,47.92,50.13, C308
4 52.44,54.79,57.21,59.76,62.27,64.92,67.64,70.55,73.67,76.64,49.3. C308
5 6(0.),67.5,70.7,74.5) C308
DATA (C(401) = 4.28,4.69,5.13), (C(1424) = 19.3,20.4,21.6,22.8, C401
1 24.1,25.4,26.7,28.1,29.6,31.1,32.6,34.3,35.9,37.7,39.6,41.3, C401
2 43.2,45.2,47.2,49.3,51.5,53.7,55.8,58.3,60.8,63.5,66.1,25.1, C401
3 6(0.),31.3,32.4,33.6), (C(518) = 17.9,18.9,20.,21.,22.2,23.3, C401
4 24.5,25.8,27.,28.5,29.8,31.2,32.7,34.2,35.8,37.5,39.1,40.9, C401
5 42.6,44.5,46.4,48.3,50.4,52.6,54.7) C401
DATA 4 C(611) = 16.3,17.2,18.2,19.1,20.1,21.2,22.3,23.4,24.5, C611
1 25.7,27.,28.3,29.6,30.9,32.4,33.8,35.3,36.9,38.4,40.1,41.8, C611
2 43.6,45.4,47.3), (C(709) = 14.8,15.3,15.85,16.3,16.85,17.45, C611
3 18.,18.55,19.05,19.6,20.1,20.45,21.35,21.95,22.5,23.1,23.8, C611
4 24.4) C611
SINTHETA = .79335
AWK = -.064
BWK = .034
CWK = -1.03E-6
WAVL = 12397.7
CSIG = 2.39E+5
XSIG = 1.5
END

```

# SUBROUTINE SEIUP

TYPE REAL LAMBDA, MU

COMMON NPROB, ID(6), NEL, EO, NZ(20), SCON(20), SCF(20), MUBAR,

1 O(20), IOX, NLP1, NF(20), NZF(20,4), Z(20), R(20,4), EC(20),

2 SIGMA(20), WK(20), MU(20,20), U(20,4), SI(20), NVAR, NELP2,

3 OCON(20), CON(20), DELCON(20), NOM(20), NS, NP(20), IMIN,

4 IMAX, IG, YMAX, DMIN

COMMON/DATA/A(92), LAMBDA(92), EDGE(92,7), C(92,8), EXP(92), WAVL,

1 SINTHETA, AWK, BWK, CWK, CSIG, XSIG DATA

DIMENSION X(20),Y(20), CR(20), XR(20)

READ 100, NPROB, ID, NEL, EO, NFIX, IMIN, IMAX, IG, YMAX, DMIN

IF(EOF,50)3,5

3 STOP

5 CALL PAGE

PRINT 200

READ 102, (NZ(I), SCON(I), SCF(I), O(I), SI(I),NOM(I),I=1,NEL)

PRINT 202, (I,NZ(I),SCON(I),SCF(I),O(I),SI(I),NOM(I),I=1,NEL)

LF = 1

NVAR = NEL - NFIX

DO 7 I = 1,NEL

IF(O(I))18,7

7 CONTINUE

NELP1 = NELP2 = NEL

GO TO 11

8 IOX = 1

NELP1 = NEL + 1

NZ(NELP1) = 8

DO 9 I = 1,NEL

IF(SI(I))10,9

9 CONTINUE

NELP2 = NELP1

GO TO 11

10 NELP2 = NELP1 + 1

NZ(NELP2) = 14

IOX = -IOX

11 DO 20 I = 1,NVAR

N = 0

```

12 IF(NZ(I).GE.36)20,12
12 IF(NZ(I).GT.21)15,13
13 N1 = NZ(I) + 1
   GO TO 16
15 N1 = NZ(I) + 2
16 N2 = N1 + 3
   DO 18 J = 1,NELP2
   IF(NZ(J).LT.N1.OR.NZ(J).GT.N2)18,17
17 N = N + 1
   LF = 0
   NZF(I,N) = J
18 CONTINUE
20 NF(I) = N
   DO 40 I = 1,NELP2
   N1 = NZ(I)
   Z(I) = FLOATF(N1)
   ENCODE (6,320,NP(I))N1
   X = EXP(N1)
   IF(N1.GT.35)23,21
21 X(2) = X(3) = X(4) = 2.73
   X(5) = 2.60
   GO TO 27
23 X(3) = X(2) = X
   IF(N1.GT.82)25,24
24 X(4) = X(5) = 2.60
   GO TO 27
25 X(5) = 2.22
   X(4) = 2.60
27 X(6) = X(7) = 2.60
   X(8) = 2.22
   EC(I) = WAVL/EDGE(N1) * .001
   SIGMA(I) = CSIG/(EO**XSIG - EC(I)**XSIG)
   DO 35 J = 1,NELP2
   N2 = NZ(J)
   Y(J) = LAMBDA(N2)
   DO 30 K = 1,7
   IF(Y(J).LE.EDGE(N1,K))35,30
30 CONTINUE
   K = 8
35 MU(J,I) = C(N1,K)*Y(J)**X(K)
   IF(LF)40,38
38 CR(I) = C(N1)/C(N1,2)
   XR(I) = X - X(2)
   YY = (AWK + BWK*Z(I) + CWK*Z(I)**3)**4
   WK(I) = YY/(1.0 + YY)
40 U(I) = EO/EC(I)
   PRINT 500
   PRINT 208, (NZ(I),I=1,NVAR)
   PRINT 209
   DO 42 I = 1,NELP2
42 PRINT 210, NZ(I), (MU(J,I),J=1,NVAR)
   CALL PAGE
   IF(LF)65,45
45 PRINT 204
   DO 47 I = 1,NELP2
   N1 = NF(I)
   DO 46 J = 1,N1
   N2 = NZF(I,J)
46 R(I,J) = CR(I)*Y(N2)**XR(I)
47 PRINT 206, I, NZ(I), N1, (NZF(I,J),R(I,J),J=1,N1)
   PRINT 212
   PRINT 214, (NZ(I),Y(I),EC(I),SIGMA(I),WK(I),U(I),I=1,NELP2)

```

```

GO TO 67
-65 PRINT -213
PRINT 216, (NZ(I),Y(I),EC(I),SIGMA(I),I=1,NELP2)
67 CONTINUE
PRINT 218
IF(LF.72.69)
69 DO 70 I = 1,NELP2
X(I) = U(I)*LOGE(U(I))-U(I)+1.0
WK(I) = WK(I)*.5
70 EC(I) = POWER(EC(I),0.3)
DO 71 I = 1,NELP2
N = NZ(I)
M = NF(I)
DO 71 J = 1,M
L = NZF(I,J)
K = NZ(L)
71 U(I,J) = (X(L)*(R(I,J)-1.0)*WK(L)*EC(I)*A(N)*MU(L,I))/(X(I)*R(I,J)
1 *EC(L)*A(K))
72 CONTINUE
PRINT 500
100 FORMAT (I6,6A8,I3,F3.0,4I2,2F5.0)
102 FORMAT(5X,15.4F10.6,5X,A5)
200 FORMAT(11X,53H-----STANDARD FOR ELEMENT Z----- OXYGEN SILICO
1N,64H NL Z CONCENTRATION FLCH1)*(1+FLUOR) FACTOR FAC
2TOR/)
202 FORMAT(I3,15,F13.6,F20.6,F13.6,F10.6,5X,A5)
204 FORMAT(///13X,9HNUMBER OF/11X,11HFLUORESCING/ 89H NL Z EL
1EMENTS ELEMENT NUMBER AND ABSORPTION JUMP RATIO OF FLUORESCING E
2LEMENTS/)
206 FORMAT(I3,15,I10,4(I7,F8.3))
208 FORMAT(10X,37HMASS ABSORPTION COEFFICIENTS---MU/RHO/19H EMITTER=,
1 I3,18I6)
209 FORMAT (9H ABSORBER)
210 FORMAT (I4,F8.0,18F6.0)
212 FORMAT (///28H Z LAMBDA EC SIGMA/)
212 FORMAT (///44H Z LAMBDA EC SIGMA OMEGA U/)
214 FORMAT (I3,F9.4,F7.3,F9.1, F8.4,F8.3)
216 FORMAT (I3,E9.4,E7.3,E9.1)
218 FORMAT (///37H LAMBDA = WAVELENGTH OF EMISSION LINE/
1 18H Z = ATOMIC NUMBER/26H R = ABSORPTION JUMP RATIO/
2 38H EC = CRITICAL EXCITATION VOLTAGE (KV)/29H OMEGA = K FLUORES
3CENCE YIELD/10H U = EO/EC)
320 FORMAT(2X,I3)
500 FORMAT(///)
END

```

```

SUBROUTINE PAGE
COMMON NPROB, ID(I6), NEL, EQ, NZ(20), SCON(20), SCE(20), MUBAR,
1 O(20), IOX, NELP1, NF(20), NZF(20,4), Z(20), R(20,4), EC(20),
2 SIGMA(20), WK(20), MU(20,20), U(20,4), SI(20), NVAR, NELP2,
3 OCON(20), CON(20), DELCON(20), NOM(20), NS, NP(20), IMIN,
4 IMAX, IG, YMAX, DMIN
NPAGE = NPAGE + 1
PRINT 200, NPROB, ID, EQ, NPAGE
200 FORMAT(12H1PROBLEM NO.,I6,3X,6A8,5X,F2.0,3H KV, 10X,4HPAGE,I3/)
END

```

```

SUBROUTINE OXYGEN

```

```

COMMON NPROB, ID(6), NEL, EO, NZ(20), SCON(20), SCF(20), MUBAR,
1  O(20), IOX, NELP1, NF(20), NZF(20,4), Z(20), R(20,4), EC(20),
2  SIGMA(20), WK(20), MU(20,20), U(20,4), SI(20), NVAR, NELP2,
3  OCON(20), CON(20), DELCON(20), NOM(20), NS, NP(20), IMIN,
4  IMAX, IG, YMAX, DMIN
  IF(IOX)5,2,10
10 CON(NELP1) = 0.0
  DO 12 I = 1,NEL
12 CON(NELP1) = CON(NELP1) + CON(I)*O(I)
  GO TO 2
5 CON(NELP1) = CON(NELP2) = 0.0
  DO 7 I = 1,NEL
  CON(NELP1) = CON(NELP1) + CON(I)*O(I)
7 CON(NELP2) = CON(NELP2) + CON(I)*SI(I)
2 RETURN
END

```

```

FUNCTION ABSORB (N)
COMMON NPROB, ID(6), NEL, EO, NZ(20), SCON(20), SCF(20), MUBAR,
1  O(20), IOX, NELP1, NF(20), NZF(20,4), Z(20), R(20,4), EC(20),
2  SIGMA(20), WK(20), MU(20,20), U(20,4), SI(20), NVAR, NELP2,
3  OCON(20), CON(20), DELCON(20), NOM(20), NS, NP(20), IMIN,
4  IMAX, IG, YMAX, DMIN
COMMON/DATA/A(92), LAMBDA(92), EDGE(92,7), C(92,8), EXP(92), WAVL,
1  SINTHETA, AWK, BWK, CWK, CSIG, XSIG
TYPE REAL MUBAR,MU
ABAR = ZBAR = MUBAR = 0.0
DO 10 I = 1,NELP2
N1 = NZ(I)
MUBAR = MUBAR + MU(N,I)*CON(I)
ABAR = ABAR + A(N1)*CON(I)
10 ZBAR = ZBAR + Z(I)*CON(I)
H = 1.2 * ABAR/ZBAR**2
CHI = MUBAR/(SINTHETA*SIGMA(N)) -1.0
ABSORB=(1.0 + H)/(CHI*(1.0 + H*CHI))
END

```

```

FUNCTION FLUOR(NN)
TYPE REAL MU, MUBAR
COMMON NPROB, ID(6), NEL, EO, NZ(20), SCON(20), SCF(20), MUBAR,
1  O(20), IOX, NELP1, NF(20), NZF(20,4), Z(20), R(20,4), EC(20),
2  SIGMA(20), WK(20), MU(20,20), U(20,4), SI(20), NVAR, NELP2,
3  OCON(20), CON(20), DELCON(20), NOM(20), NS, NP(20), IMIN,
4  IMAX, IG, YMAX, DMIN
COMMON/DATA/A(92), LAMBDA(92), EDGE(92,7), C(92,8), EXP(92), WAVL,
1  SINTHETA, AWK, BWK, CWK, CSIG, XSIG DATA
N = NN
FLUOR = 0.0
IF(NF(N))3,2
2 RETURN
3 M = NF(N)
DO 25 J = 1,M
L = NZF(N,J)
IF(NZ(L).GT.35)5,7
5 PRINT 200, NZ(L)
200 FORMAT(/58H FLUORESCENCE CORRECTION CANNOT BE CALCULATED FOR ELEM
1ENT ,I2//)
GO TO 25

```

```

7 FMUBAR = 0.0
DO 10 I = 1,NELP2
10 FMUBAR = FMUBAR + CON(I)*MU(L,I)
V = SIGMA(L)/FMUBAR
V = LOGF(1.0 + V)/V
ULC = MUBAR/(FMUBAR*SINTheta)
ULC = LOGF(1.0 + ULC)/ULC
FLUOR = FLUOR + CON(L)*U(N,J)*(ULC + V)/FMUBAR
25 CONTINUE
END

```

```

SUBROUTINE PRNTPLOT (N,NO)
COMMON NPROB, ID(6), NEL, EO, NZ(20), SCON(20), SCF(20), MUBAR,
1 O(20), IOX,NELP1,NF(20),NZF(20,4),Z(20),R(20,4),EC(20),
2 SIGMA(20),WK(20),MU(20,20),U(20,4),SI(20),NVAR,NELP2,
3 OCON(20),CON(20),DELCON(20),NOM(20),NS,NP(20),IMIN,
4 IMAX,IG,YMAX,DMIN
COMMON/PP/NAME2(500),Y(500,20),TOT(500)
DIMENSION IPREF(9),X(500),N(20)
DATA (IPREF = 4,3,5,0,1,2,6,7,9)
IF(NO.LE.10)3,1
1 N1 = N3 = 1
N2 = 10
GO TO 4
3 N1 = 1
N3 = 0
N2 = NO
4 CALL PAGE
PRINT 220, (N(I),I=N1,N2)
220 FORMAT(25X,56HCONCENTRATIONS CORRECTED FOR ABSORPTION AND FLUORESC
1ENCE//15X,5HTOTAL,10(5X,A5))
DO 10 I = 1,NS
PRINT 256,NAME2(I),TOT(I), (Y(I,J),J=N1,N2)
256 FORMAT(2X,A8,11(2PF10.4))
IF(XMODF(I,5))10,5
5 IF(XMODF(I,45))8,7
7 CALL PAGE
PRINT 220, (N(K),K=N1,N2)
GO TO 10
8 PRINT 400
400 FORMAT ( )
10 CONTINUE
IF(N3)11,14
11 N1 = 11
N2 = NO
N3 = 0
GO TO 4
14 IF(IG)15,90
90 RETURN
15 IF(N.NE.NP)30,16
16 IF(IOX)90,30
30 YLEN = 8.6614
YYMAX = YMAX*1.1
XLEN = FLOATF((NS+7)/8)
PX1 = XLEN + 1.0
PX2 = XLEN + 1.5
CALL CCPLLOT(XLEN+3.0,0,0)
DY = YYMAX/YLEN
33 DO 35 I = 1,NS
35 X(I) = I

```



```

NX = XMINOF(NO,9)
PY1 = .8924
PY2 = .7874
DO 40 J = 1,NX
CALL P2LINE (X,Y(1,J),NS,1,1,IPREF(J),.07,0.0,8.0,0.0,DY)
CALL CCSYMBOL (PX1,PY1,.21,IPREF(J),0.0,-1)
CALL CCSYMBOL (PX2,PY2,.21,N(J),0.0,5)
PY1 = PY1 + .5
PY2 = PY2 + .5
40 CONTINUE
CALL P2LINE (X,TOT,NS,1,1,11,.07,0.0,8.0,0.0,DY)
CALL CCSYMBOL (PX1,PY1 ,.35,11,0.0,-1)
CALL CCSYMBOL (PX2,PY2, .35,5HTOTAL,0.0,5)
CALL CCAXIS (0.,0.,ID,-48,XLEN,0.0,0.0,8.0 ,8.0)
CALL CCAXIS (XLEN,0.,14H CONCENTRATION,14,YLEN ,90.,0.0,DY,-12.7)
CALL CCAXIS (0.,YLEN ,ID,-48,XLEN,0.0,0.0,8.0 ,8.0)
CALL CCAXIS (0.,7.874,ID,-48,XLEN,0.0,0.0,8.0 ,8.0)
CALL CCAXIS (0.,0.,14H CONCENTRATION,14,YLEN ,90.,0.0,DY,12.7)
DO 50 I = 1,NS
IF(NAME2(I).EQ.1H )50,45
45 PX = X(I)*.125
CALL CCSYMBOL (PX,YLEN,.14,NAME2(I),45.0,8)
50 CONTINUE
CALL CCLOT (0,0,-3)
END

```

## APPENDIX 2: INPUT SPECIFICATIONS

A. Data Cards for Program EMX

<u>Columns</u>	<u>Description</u>
IDENTIFICATION CARD:	One at the beginning of each problem.
1-6	NPROB (problem number). Up to six digits (all numerals), right justified*, no decimal point.
8-54	ID - alphanumeric information (letters, numbers, symbols) for problem identification.
NOTE: NPROB and ID will appear as a heading on each page of output and on any graphs associated with this problem. If NPROB = 0, the program will terminate.	
56	NEL (total number of elements analyzed in this problem). NEL $\leq$ 9.
57-58	NDT (number of readings in each deadtime data point). NDT $\leq$ 99. Right justified, no decimal point. If no deadtime data, NDT = 0.
59-60	NS (number of readings in each sample peak, sample background or standard background data point). NS $\leq$ 99. Right justified, no decimal point. If the problem involves only the calculation of deadtime, NS = 0.
NOTE: If readings are not grouped according to NS and NDT specifications, program will print an error message and move on the next problem, if any, without making any calculations; or, if the total number of consecutive equivalent readings happens to be evenly divisible by NS (or NDT for deadtime readings), it will group data incorrectly. Standard peak data points may be made up of a variable, unspecified number of readings $\leq$ 100. If one data point includes both standard peak and standard background data, it will be handled as "standard peak".	
62	MBKGD (method of taking background readings). If MBKGD = 0, the program expects to find a pair of background data points for each sample or standard peak data point. If MBKGD = 1, one pair of background data points is averaged and the result subtracted from all of the appropriate peaks until the time when another pair appears or until the end of the data set. If no background points are given, no background will be subtracted from the points in that data set. There will be no indication of this in the final output.

\*"Right-justified" means that the rightmost digit of a number is in the farthest right column allowed for the number; any blank columns are on the left of the number.

Columns      Description

CAUTION: Background data points are assumed to occur in pairs (not necessarily adjacent), which are averaged to find true background. Reading down each spectrometer column, the first two background points (wherever they may be) are assumed to make up the first pair, and so on. If there is an odd number of background points, the last one will be used alone as a true background. This means that if one member of the first pair is omitted, all further points will be grouped incorrectly.

In BKGD Method 0, the omission of a background or peak data point will cause all succeeding background points to be subtracted from the wrong peaks.

62-65	SLIMIT (limit of scatter allowed within a standard peak data point). Either right-justified integer or the decimal point must be included. If in any standard peak data point $\sigma > \text{SLIMIT} \cdot \sqrt{N}$ (where $\sigma$ = root mean square, $N$ = number of counts) the computer will print an error message and move on to data for the next problem, if any. It is suggested that SLIMIT = 2 to 3.
67	IG. If IG = 1, computer will make a plot of the concentration of each element or oxide and total concentration of all elements analyzed at each point on the sample. If IG = 0 or blank, no plot will be made.
68-70	YMAX--(the value of the current at the right-hand edge of the deadtime curve plot). Whenever deadtime is calculated, a plot is made of counts/current as a function of current, and a value must be given for YMAX. For ease in reading values from the plot, YMAX should be a number with only one significant figure. Decimal point required. If no deadtime data, may be left blank.
71-73	YMAX (maximum y-value on concentration plot, which will be increased by 10 percent by the program). Decimal point required. If IG = 0, may be left blank. Example: if elements analyzed are expected to total 100%, set YMAX = 1.0. Plot will show concentrations up to 110%.

ELEMENT CARD: One "element card" is needed for each element analyzed in the problem. Cards must be arranged so that NL's (see below) are consecutive integers from 1 to NEL. If elements analyzed are not numbered this way in probe output, NEL must be changed and dummy cards must be made for the missing elements. For example, if only three elements are being analyzed but these are numbered 2,

<u>Columns</u>	<u>Description</u>
3, and 6 in the probe data, NEL must be set equal to 6 and there must be an element card (with NL in column 1) for Elements 1, 4 and 5 as well as for the elements analyzed. (This will take more computer time than if the elements analyzed had been numbered 1, 2 and 3 in the first place.)	
1	NL (the element code number assigned to this element at the time probe data was taken). Elements may be numbered in any order, without regard to atomic number, order in which analyzed, etc.
2-4	NO(NL) (atomic number of the element). Right-justified, no decimal point.
5-10	WTPC(NL) (concentration of element in its standard). NOTE: If, for example, standard contains 25 percent Fe, WTPC = .25. Decimal point required; may appear anywhere within the field.
11-25	TAU(NL) (deadtime in seconds). E-format; exponent of 10 must be in Col. 25; decimal point required. If TAU is to be computed by the program, put a zero somewhere within Cols. 11-22. If deadtime correction is to be omitted, put any negative number (with decimal point) somewhere within Cols. 11-22. If the TAU from some other element is to be used for this element, set TAU = NL of the element from which the TAU is to be used.
26-35	O(NL) (Oxygen factor). The oxide concentrations will be calculated as $CON(NL) * (1 + O(NL))$ . Decimal point required; may be left blank if no oxygen. Example: to convert silicon concentration into concentration of $SiO_2$ , $O = 1.139$ .
36-45	SI(NL) (silicon factor). If silicon is not analyzed for, silicon concentrations can be calculated in same manner as oxygen concentrations. Decimal point required, or may be left blank.
51-55	NOM(NL) (name of oxide or other element combination to be used in headings on printout and plots. Example: $Al_2O_3$ )

PROBE DATA RECORDS: One card or magnetic tape record for each reading from probe. If records are on magnetic tape, they must be written in BCD.

<u>Columns</u>	<u>Description</u>
PROBE DATA RECORDS (Continued)	
1-6	Time (in hundredths of sec.)
7-12	Current
13-18	Scanner 1 counts
19-24	Scanner 2 counts
25-30	Scanner 3 counts
	No decimal points. If a column is left out in the output from probe, it must contain zeros or blank spaces.
31-36	KODE (a set of six code digits to identify the element and type of reading. NL = identifying number of the element being analyzed for, and may be any arbitrary number from 1 to 9. If NL = 0, that reading for that scanner will be disregarded. KD = type of reading.
	If KD = 0, sample peak
	1, sample background
	2, standard peak
	3, standard background
	4, deadtime reading
	Col. 31 KD } for Scanner 1
	32 NL }
	33 KD } for Scanner 2
	34 NL }
	35 KD } for Scanner 3
	36 NL }
37-44	NAME (alphanumeric information for identification of a data point) May be left blank.
BREAK CARD: Data sets must be separated by a "break" card, which contains zeros in Columns 31-36. Any data in other columns will be ignored.	
After the last data card for each problem, there must be a card with 999999 in columns 31-36.	
After the 999999 card of the last problem for the computer run, there must be one blank card. (Or if data records are on tape, blank card must be after last ELEMENT CARD of last problem.)	
B. <u>Data Cards for Program BNX2</u>	
<u>Columns</u>	<u>Description</u>
IDENTIFICATION CARD: One at the beginning of each problem.	
1-6	NPROB (problem number). Up to six digits (all numerals), right justified, no decimal point.
7-54	ID - alphanumeric information (letters, numbers, symbols) for problem identification.

<u>Columns</u>	<u>Description</u>
NOTE: NPROB and ID will appear as a heading on each page of output and on any graphs associated with this problem. If DATA RECORDS (see below) are on punched cards, only one problem may be run at one time. If DATA RECORDS are on magnetic tape, any number of problems may be run at once, as long as DATA RECORDS are all on one tape. In this case, data <u>cards</u> should be followed by one blank card.	
55-57	NEL - number of elements for each sample to be read from DATA RECORDS. NEL $\leq$ 20.
58-60	E0 - operating voltage in KV. Right justified, no decimal point.
61-62	NPIX - number of fixed elements. Concentrations for these elements will be read from data records and used in corrections but will not themselves be corrected. All "fixed elements" must appear after the other elements on ELEMENT CARDS and DATA RECORDS. Right justified, no decimal.
63-64	IMIN - minimum number of iterations. Right justified, no decimal.
65-66	IMAX - maximum number of iterations. Right justified, no decimal.
68	IG. IG = 1 if a graph is to be plotted, IG = 0 if no graph desired.
69-73	Maximum Y-value on graph (which will be increased by 10 percent by the program). If IG = 0, may be left blank. Decimal point required.
74-78	DMIN. The calculation will be iterated at least IMIN and no more than IMAX times. Between these limits, iteration will stop when concentrations of no elements present in amounts greater than one percent change more than DMIN from one iteration to the next.

ELEMENT CARD: One needed for each element in the problem. Cards must be arranged in same order as element concentrations appear on DATA RECORDS. No element card is needed for oxygen, the concentration of which will be calculated on the basis of the other element concentrations. (Silicon can be calculated in the same manner; then no element card or probe data would appear for silicon)

6-10	NZ(I) - atomic number of element i. Right justified, no decimal.
11-20	SCON(I) - concentration of element i in its standard. Decimal point required.

<u>Columns</u>	<u>Description</u>
21-30	SCF(I) - correction factor for the standard of the ith element: $f(chi) \cdot (1 + I_{ci}/I_i)$ . If SCF = 0, all SCF for this problem must = 0. In this case correction factors are calculated for the standard, and new ELEMENT CARDS are punched for later use (see Sec. IIIC). Decimal point required.
31-40	O(I) - oxygen factor: the oxygen concentration in the sample will be calculated as $CONO_2 \cdot O_i = 1, NEL$ . Oxide concentrations will be calculated as $CON(1 + O_i)$ . Decimal point required, or may be left blank if no oxygen.
41-50	SI(I) - silicon factor. If silicon is not analyzed for, silicon concentrations can be calculated in same manner as oxygen concentrations. Decimal point required, or may be left blank.
56-60	NOM(I) - name of oxide or other element combination to be used in headings on printout and plots. Example: $Al_2O_3$
PROBE DATA RECORDS: any number up to 500. May be on punched cards or on magnetic tape on Logical Unit 3.	
1-8	NAME - alphanumeric information to identify the sample or sample point. May be left blank.
9-16	Observed concentrations ( $I_A/I(A)$ ) of elements in sample. Must appear in same order as element cards, with fixed elements last. E8.0 format - for example, 33.3 percent would appear as 3330E-04. 5 ppm would appear as 0005T-06.
17-24	
25-32	
33-40	
41-48	
49-56	
57-64	
65-72	
73-80	

If the problem includes more than 9 elements, two records (cards) may be included for each sample or sample point. The concentration of the 10th element would appear in columns 9-16 of the second card; the 11th, in columns 17-24 etc.

#### C. Special Tapes

To make EMX and ENX2 as flexible as possible in input and output operations, the use of several special tapes is built into the programs. These tapes must be provided, bypassed, or equivalenced to some standard I/O unit; they cannot be ignored.

Data from the microprobe is read into Program EMX from Tape 2. If probe data is actually to be on punched cards, Tape 2 must be equivalenced on the appropriate control card to the standard input unit.

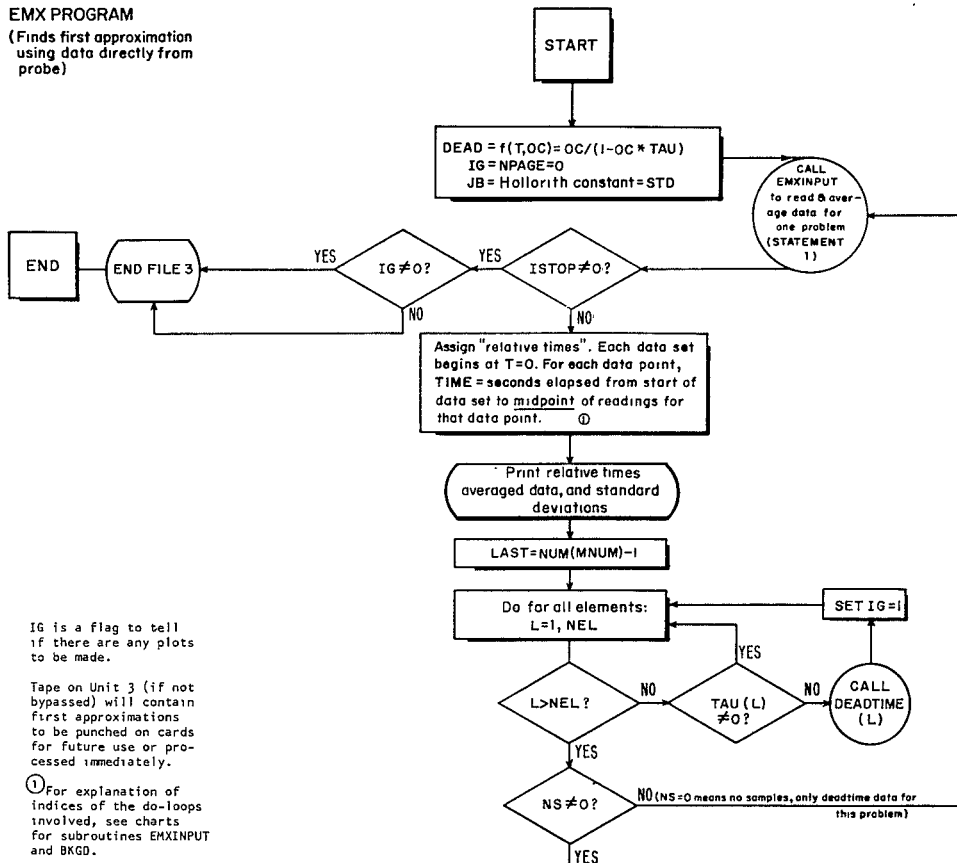
Results from Program EMX that are to be used as input for Program EMX2 will be written on Tape 3. If the user prefers to receive this output in the form of punched cards, Tape 3 may be equivalenced to the standard punch unit or cards may be punched later from the tape. If both programs are being run together as a multiple-execution job, this intermediate output could most economically be on a standard scratch tape; then Tape 3 would be equivalenced to the standard scratch tape. This tape must be rewound between the execution of EMX and EMX2. If EMX is being run alone and no such output is desired because no further corrections are to be made to the data, the program user must specify that Tape 3 be bypassed.

If input to Program EMX2 is to be entirely from punched cards, Tape 3 must be equivalenced to the standard input unit.

A special tape must be provided for plotting information when plots are desired.

## EMX PROGRAM

(Finds first approximation  
using data directly from  
probe)

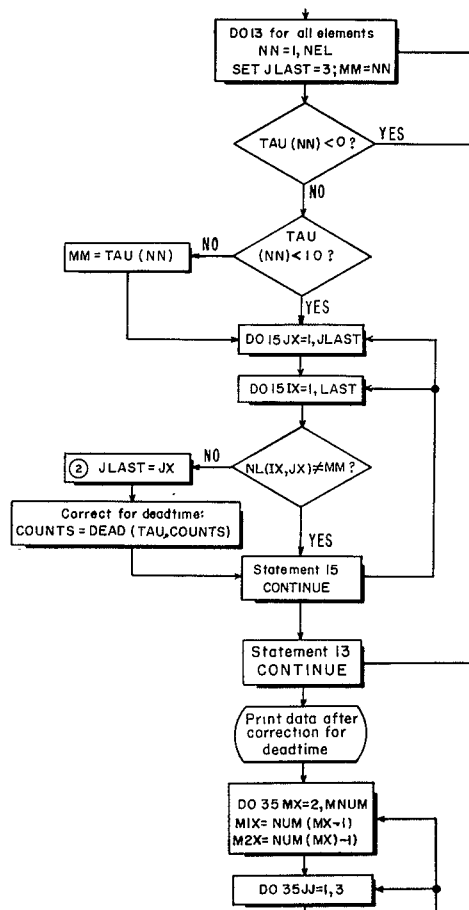


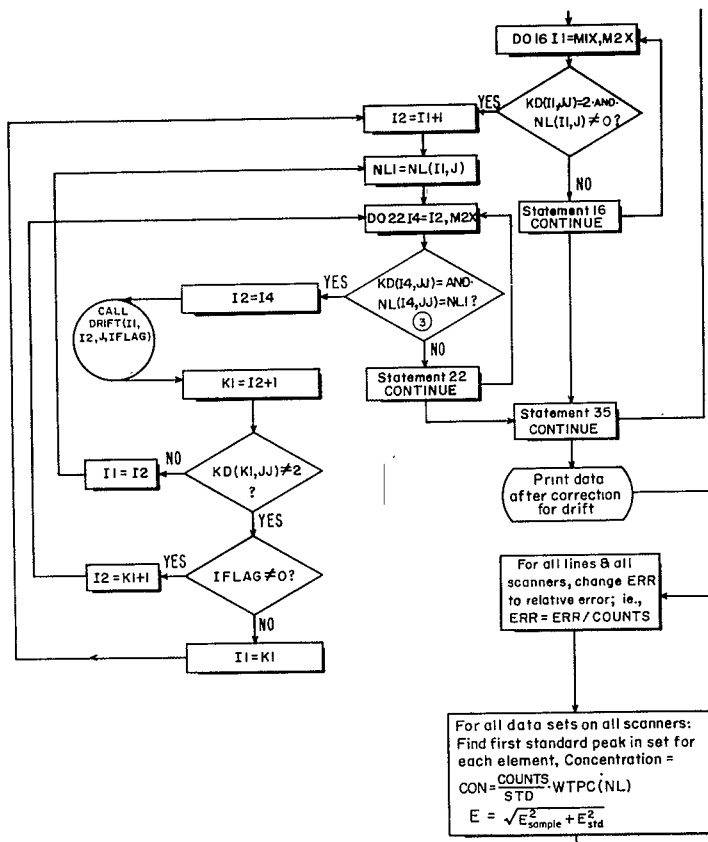
LAST = index of last line  
of data for this problem.

NN = element number

Note: if  $\text{TAU} < 0$ , it  
means don't correct for  
deadtime. If  $\text{TAU} = 0$ ,  
find correct TAU using  
data. If  $\text{TAU} > 1$ , use  
TAU from element tau.

② Once a sample no. NN  
is found, it is assumed  
that all of that element  
will be on the same  
scanner.





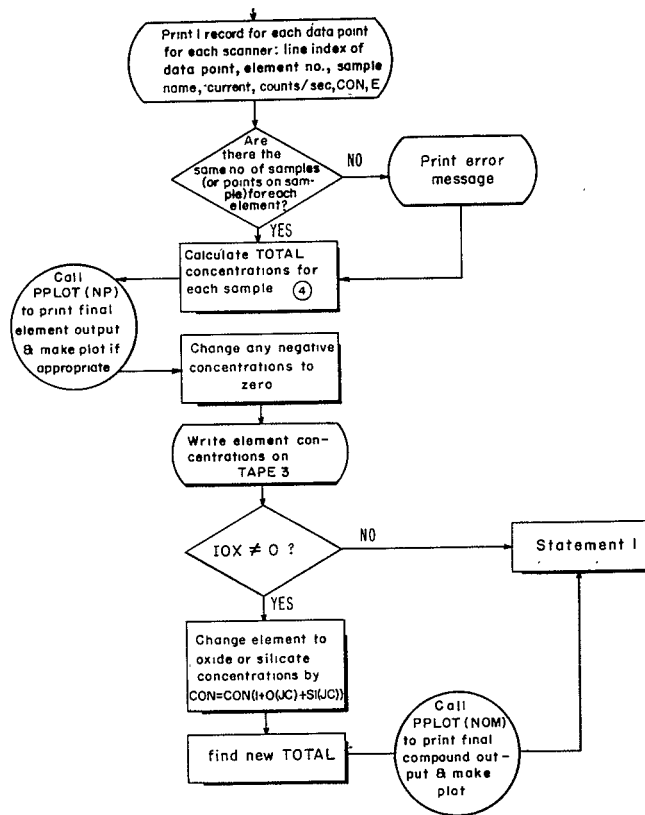
③ Look for first standard peak (I1). If KD = 2, data point is a standard peak.

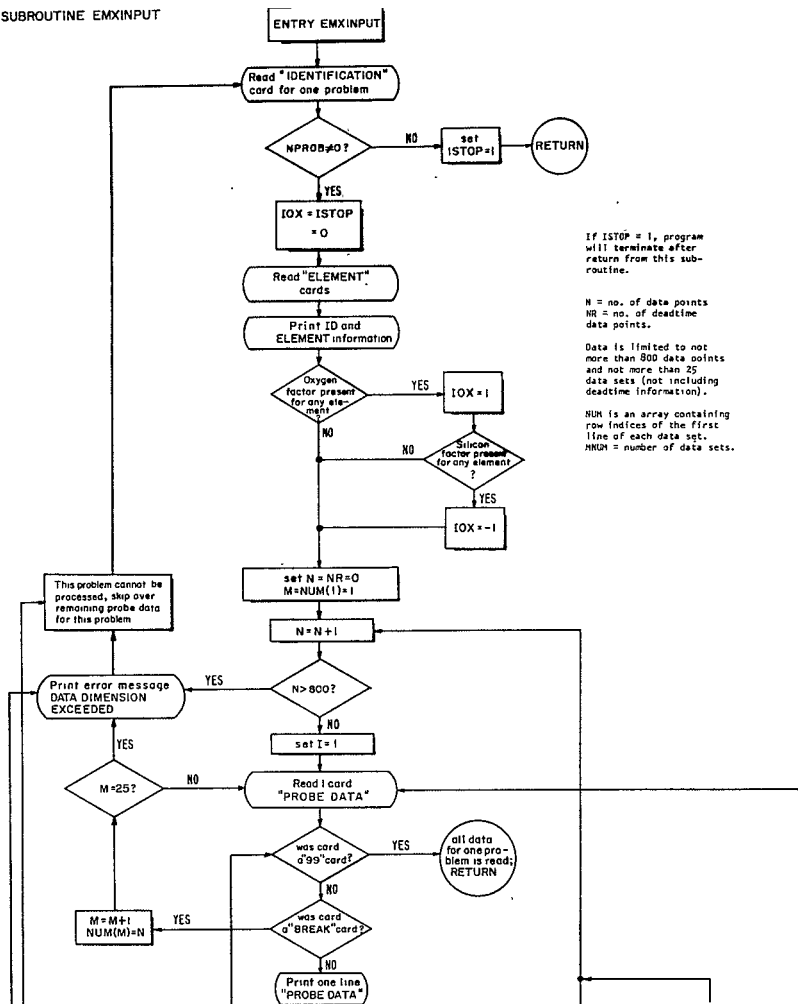
Subroutine DRIFT interpolates between I1 and I2 to correct for drift.

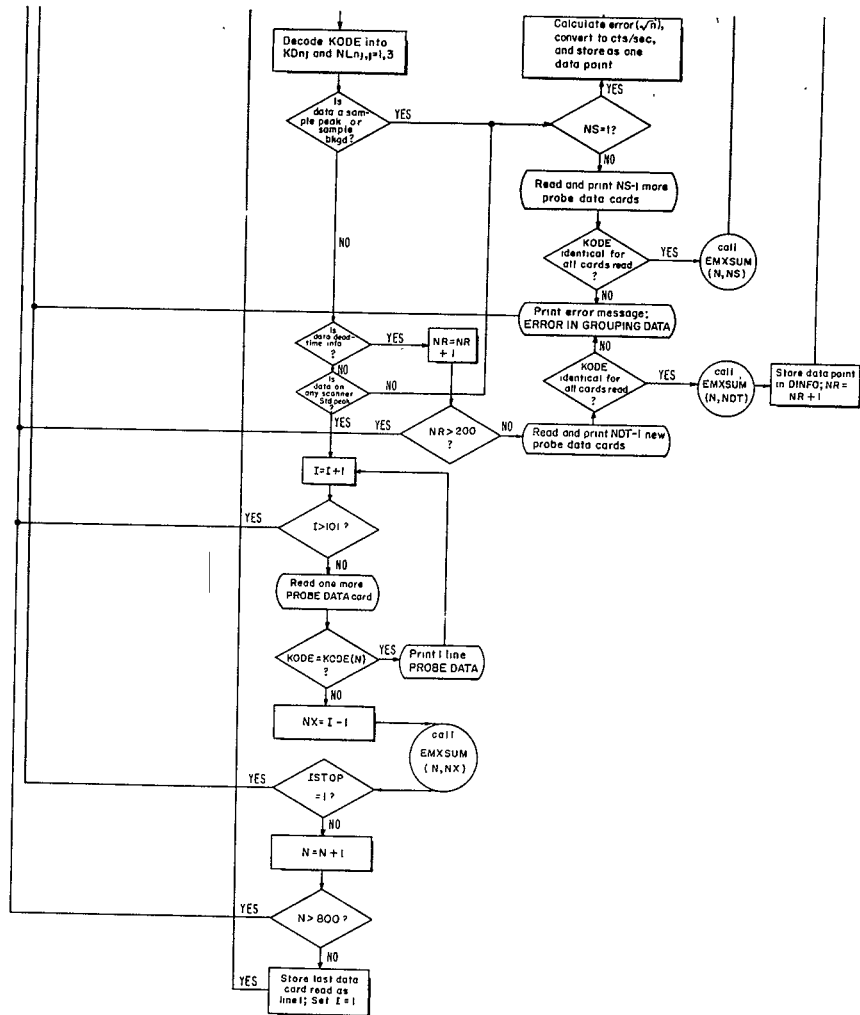
If IFLAG = 1 after return from DRIFT subroutine, no drift correction was made between I1 and I2. Now we must check for drift between the original I1 and the next standard.

WTPC(NL) = concentration of element NL in its standard.









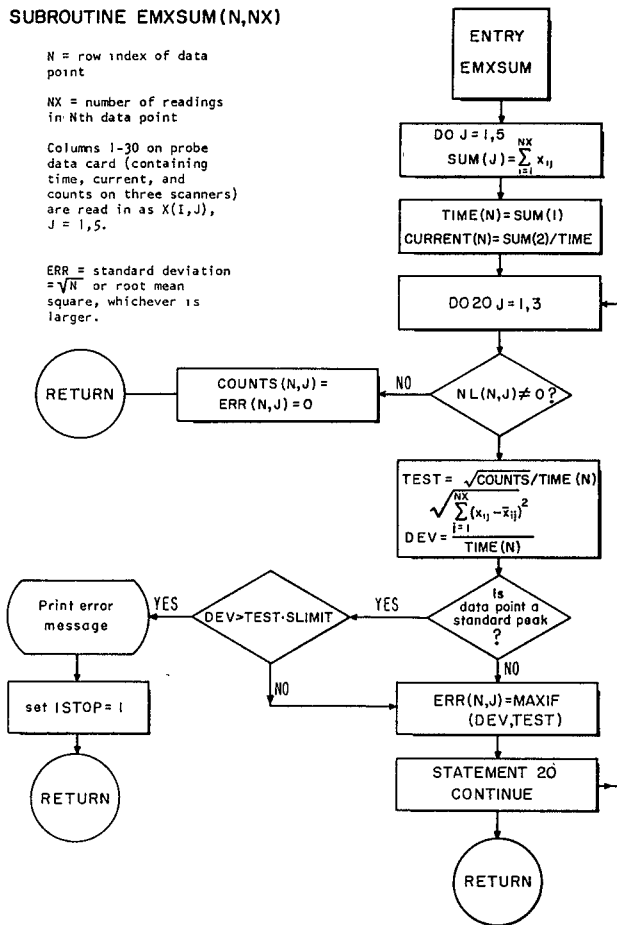
# SUBROUTINE EMXSUM(N,NX)

N = row index of data point

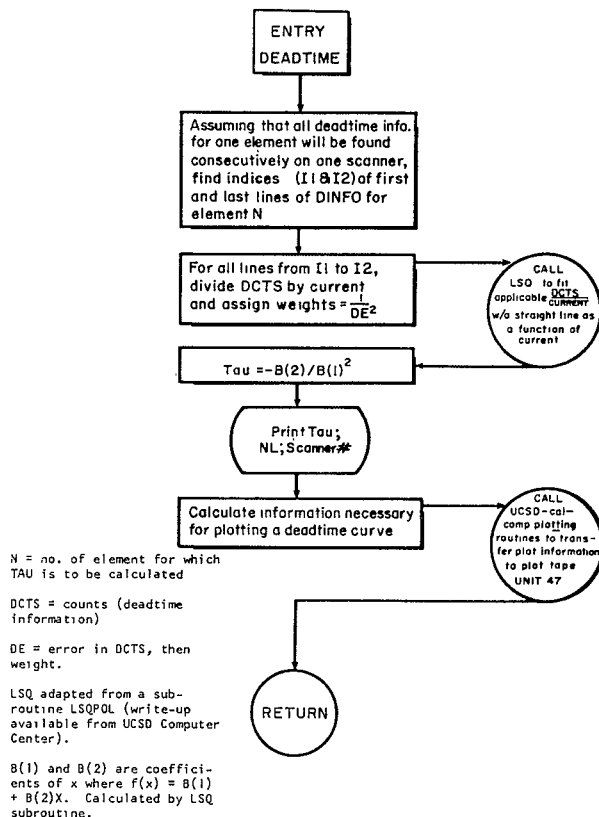
NX = number of readings in Nth data point

Columns 1-30 on probe data card (containing time, current, and counts on three scanners) are read in as X(I,J), J = 1,5.

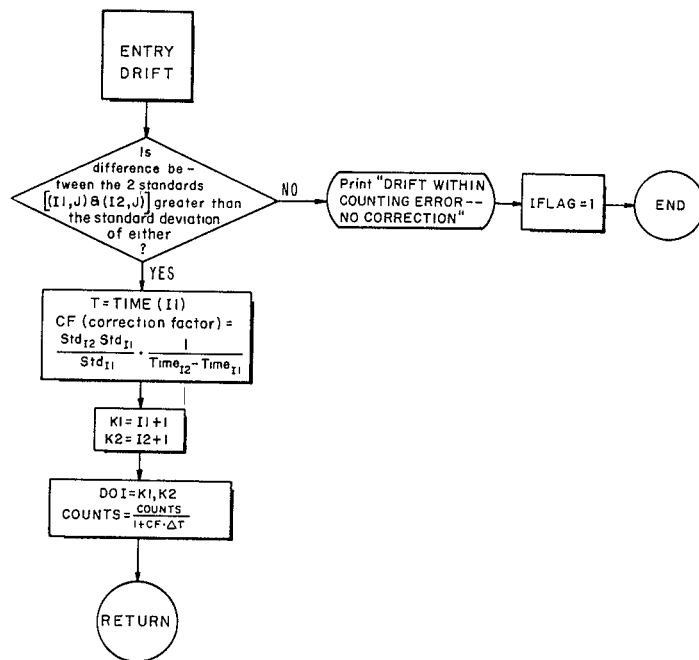
ERR = standard deviation =  $\sqrt{N}$  or root mean square, whichever is larger.



# SUBROUTINE DEADTIME(N)



Subroutine DRIFT (I1,I2,J,IFLAG)



K1-K2 are limits within which to correct for drift

$\Delta T = \text{TIME}(I) - T$

# SUBROUTINE BKGD(KODE)

J = no. of scanner

Subroutine is done twice,  
once for KODE=3 (standard  
bkgd) and once for KODE=1  
(sample bkgd).

M1 and M2 are indices of  
first and last lines of a  
data set

(NO BACKGROUND FOR THIS DATA SET ON THIS SCANNER)

J1 is first line to look  
on for a sample from which  
to subtract B.

① Look for an appropriate  
background reading.

I1 = line of first of a  
background pair.

NL1 = element to which I1  
applies.

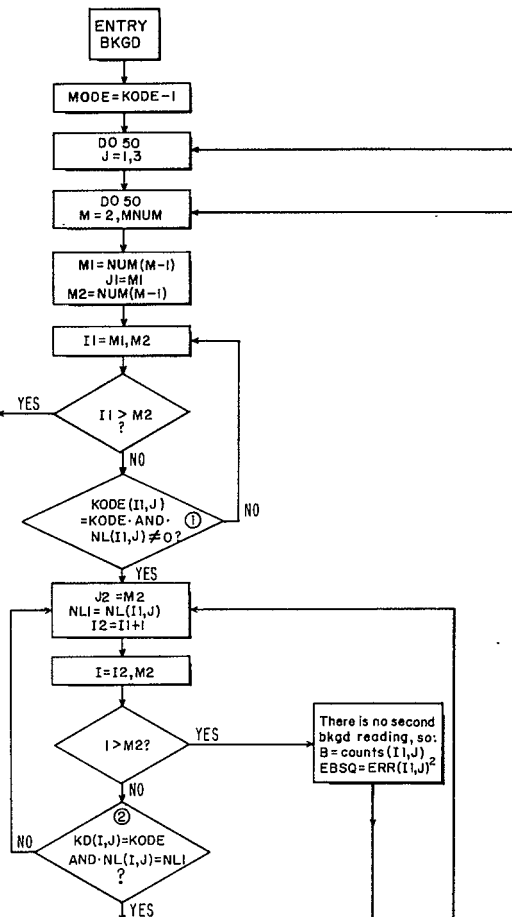
B = true background

$EBSQ = (\text{error in } B)^2$

I2 = line of second of a  
background pair.

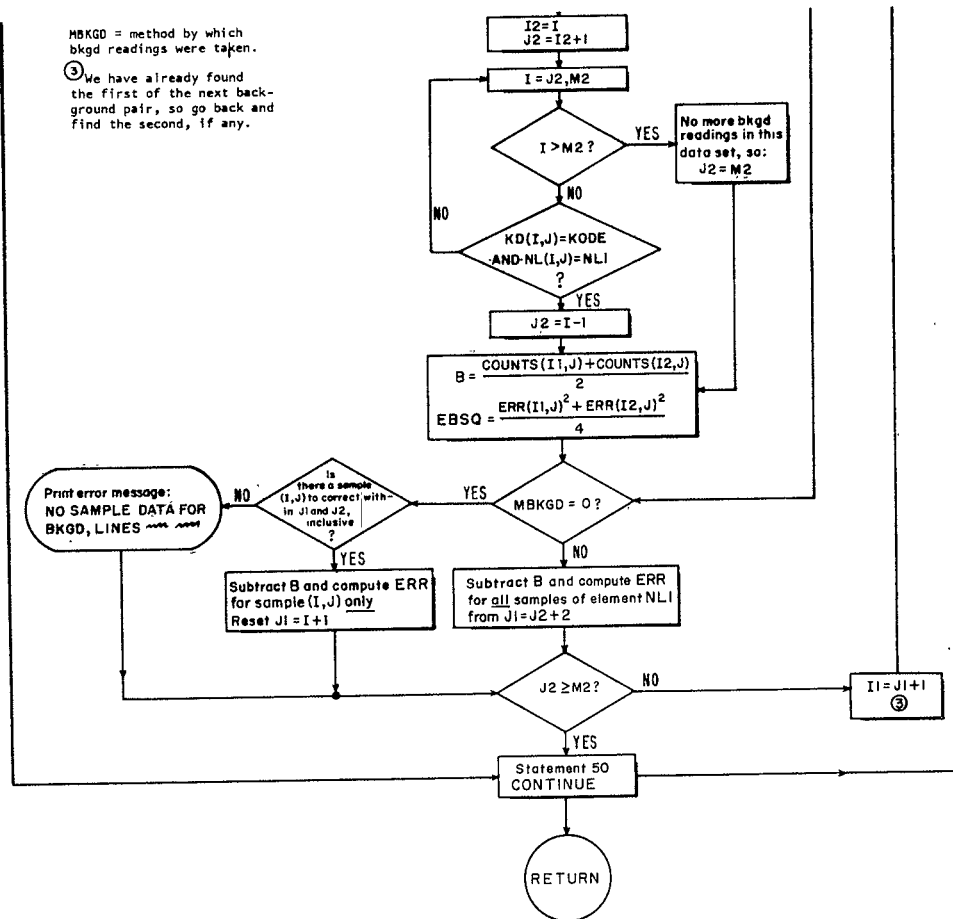
J2 is last line on which  
to look for a sample from  
which to subtract B

② Samples to which B ap-  
plies must be before any  
more background readings,  
so find 3rd background,  
if any.



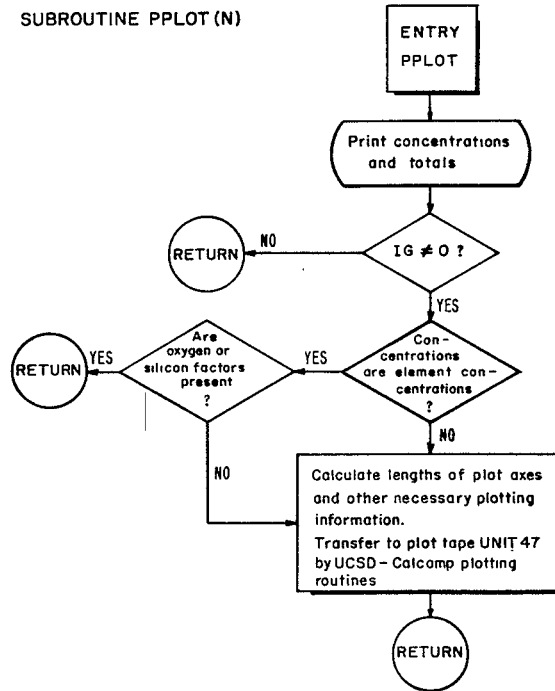
MBKGD = method by which  
bkgd readings were taken.

③ We have already found  
the first of the next back-  
ground pair, so go back and  
find the second, if any.

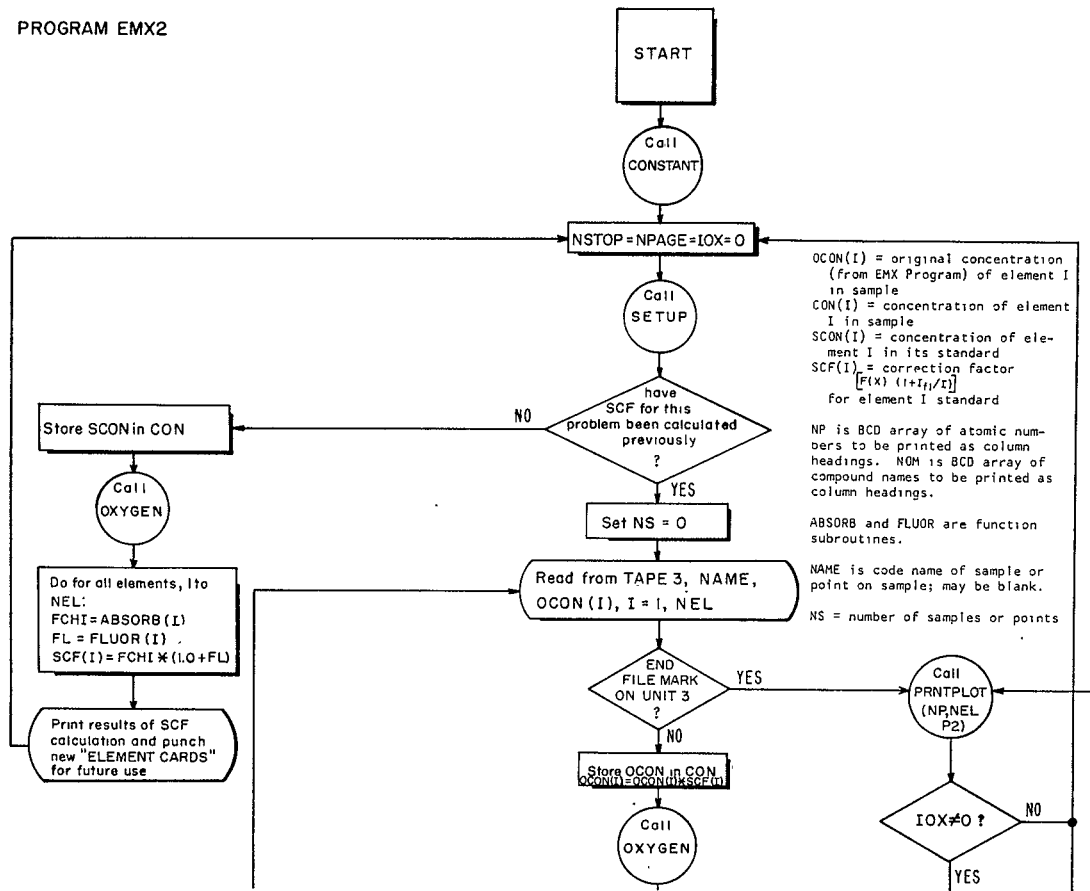


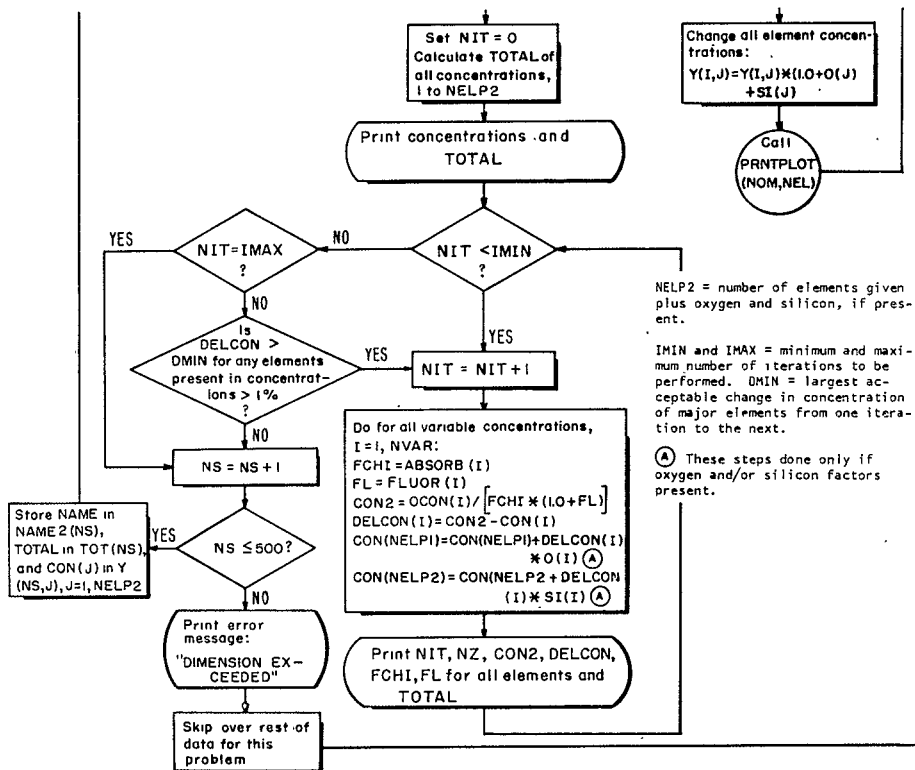


SUBROUTINE PLOT (N)

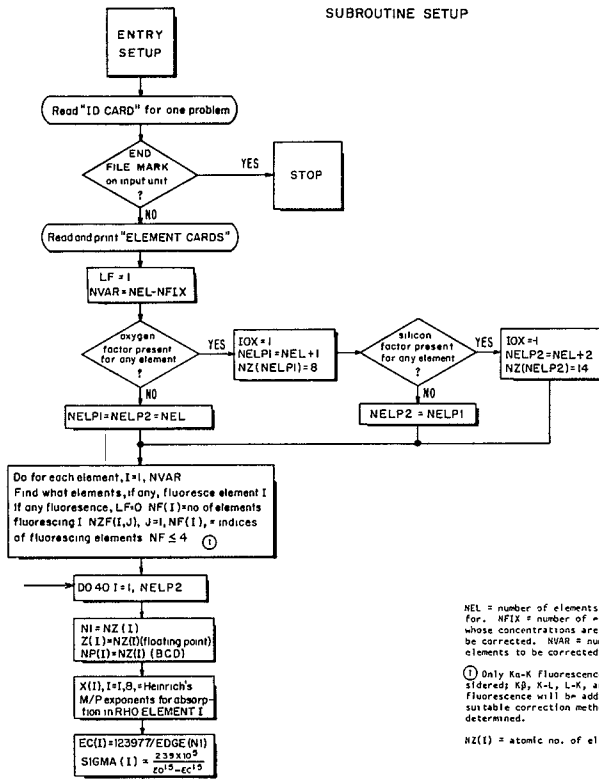


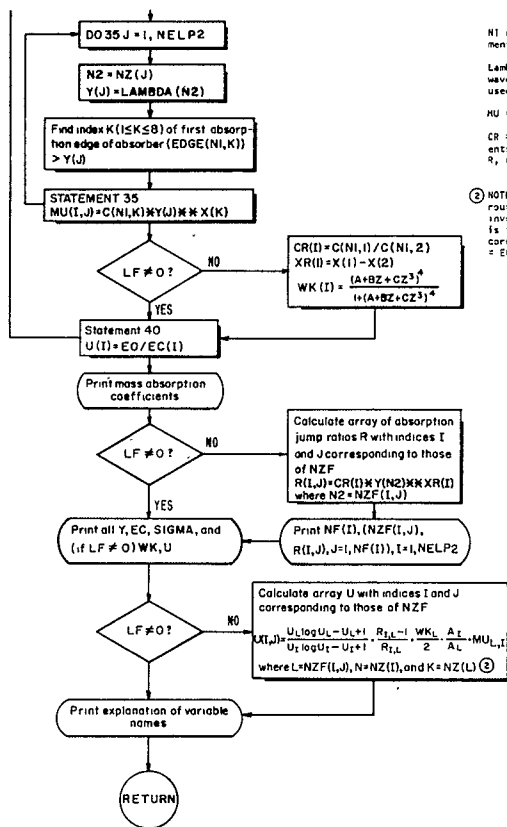
## PROGRAM EMX2





## SUBROUTINE SETUP





NI refers to atomic no. of element as absorber, N2, as emitter.

Lambda array contains the one wavelength (either  $\lambda_L$  or  $\lambda_K$ ) used for each element.

HU = mass absorption coefficient.

CR = ratio of Heinrich coefficients to be used in calculating R, the absorption jump ratios.

③ NOTE: after exit from this subroutine, U is an expression involving many variables which is to be used in fluorescence corrections. IT IS NO LONGER  $\leq EO/EC$ .